

TZR

The 8th International Conference on Micro-Pattern Gaseous Detectors Oct.14th - Oct.18th 2024 USTC·Hefei, China

Technical challenges for the new T2K High Angle TPCs

17 October 2024

Stefano Levorato

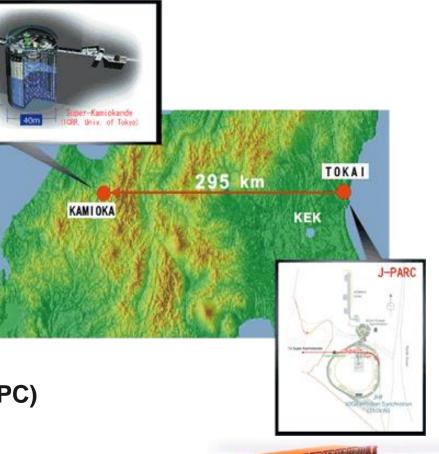
on behalf of the T2K ND280 upgrade group

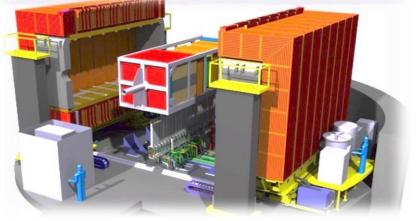


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Outlook

- The T2K ND280 experiment
- The ND280 upgrade project
 - The motivations
 - The upgrade
- The High Angle Time Projection Chambers (HATPC)
 - A short detector description
- The Encapsulated Resistive Anode Micromegas (ERAM)
 - Construction
 - Quality assessment
 - Performance
- Conclusions

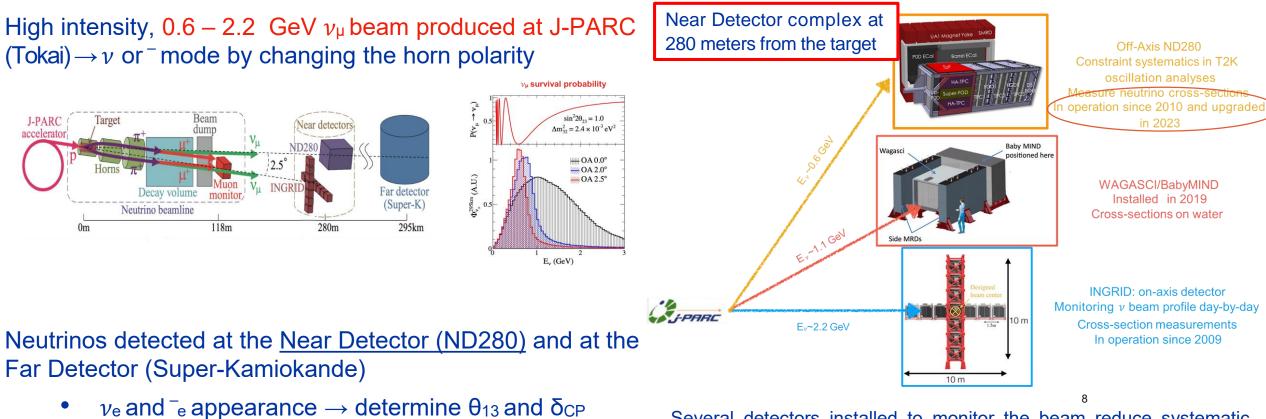




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The T2K experiment and the role of ND280

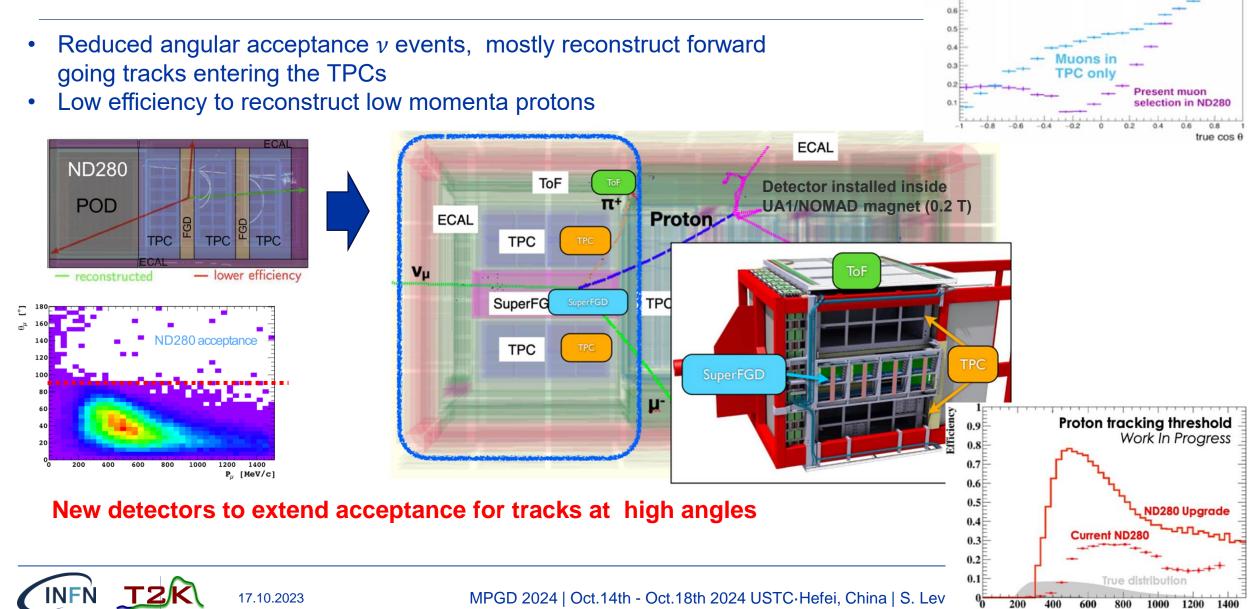


• Precise measurement of ν_{μ} disappearance $\rightarrow \theta_{23}$ and $|\Delta m_{32}^2|$

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Several detectors installed to monitor the beam reduce systematic uncertainties in oscillation analyses, and measure ν and $\bar{\nu}$ cross-sections

ND to measure un-oscillated beam flux and ν cross sections



The ND280 experiment: the upgrade

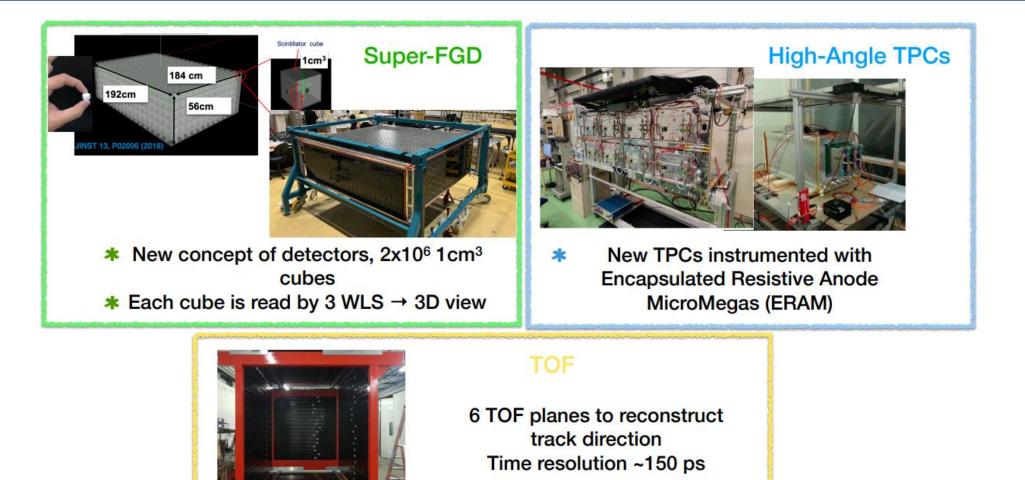
momentum (MeV)

Muons in TPC or

stopping in SuperFGD

0.9

ND280: the upgrade detectors





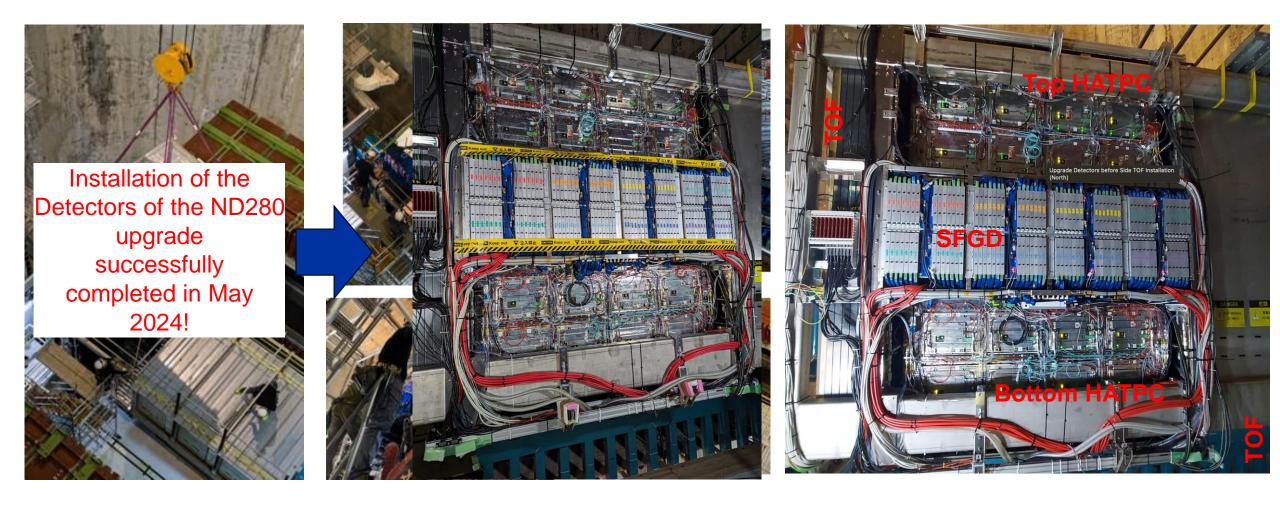
ND280: upgrade completed! Top-HATPC installed in the end of April 2024







ND280: upgrade completed! Top-HATPC installed in the end of April 2024







The ND280 experiment: High Angle TPC highlights

- The HATPC detector
 - A short introduction
- Encapsulated Resistive Anode Micromegas (ERAMs)
 - The realization of the 50 ERAM sensors
 - The ERAM characterization
 - Detector response, signal
- HATPC performance





The ND280 experiment: HATPC requirements

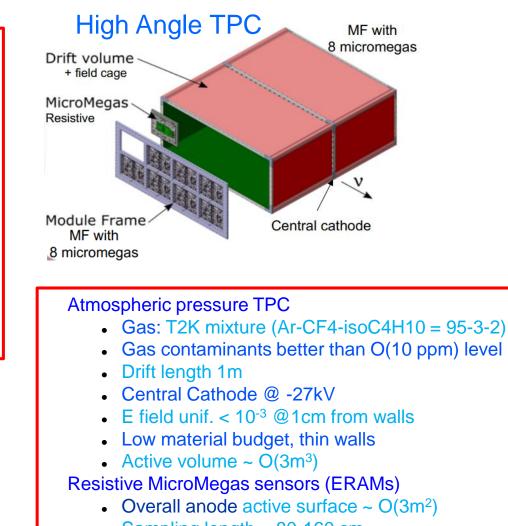
Momentum resolution $\sigma_p/p < 9\%$ at 1GeV/c (neutrino energy)

Energy resolution $\sigma_{dE/dx} < 10\%$ (PID muons and electrons)

Space resolution O(500 μm) (3D tracking & pattern recognition)

Low material budget walls ~ 3% X₀ (matching tracks from neutrino active target)

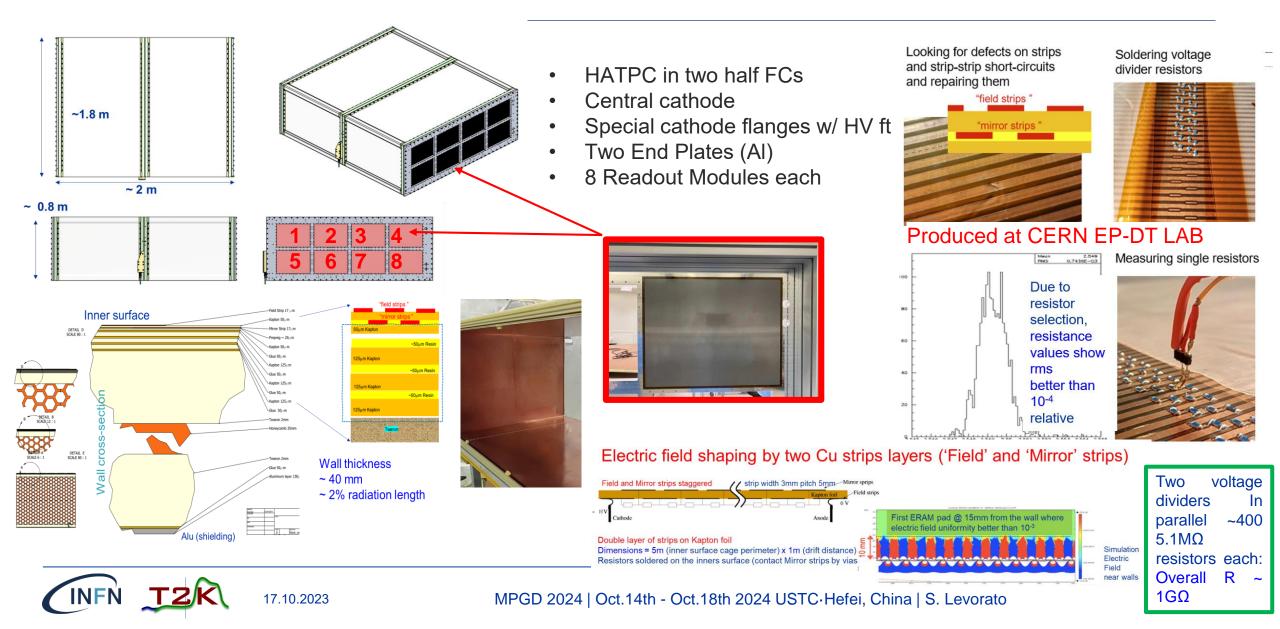
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- Sampling length ~ 80-160 cm
- pads ~ 1x1cm²
- 10k+10k channels / TPC @ End Plates (Anodes)

9

HATPC, an overview on the main elements



The ND280 experiment: High Angle TPC highlights

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ERAM: MicroMegas with DLC resistive foil

- **Resistive layer** enables charge spreading \rightarrow space resolution below 500µm with larger pads
- \rightarrow less FEE channels (lower cost)
- \rightarrow improved resolution at small drift distance (where transverse diffusion cannot help)

Resistive layer prevents charge build-up and quench sparks

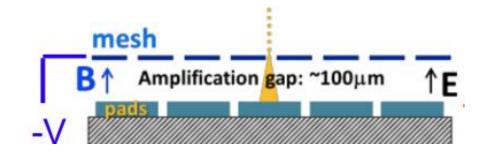
- \rightarrow enables operation at higher gain
- \rightarrow no need for spark protection circuits for ASICs
 - \rightarrow compact FEE \rightarrow max active volume

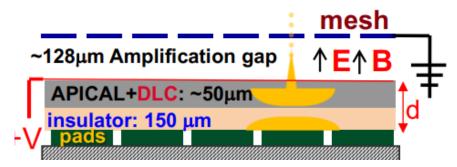
Resistive layer encapsulated and properly insulated from GND

 \rightarrow Mesh at ground and Resistive layer at +HV

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- \rightarrow improved field homogeneity \rightarrow reduced track distortions
- \rightarrow better shielding from mesh and DLC \rightarrow potentially better S/N

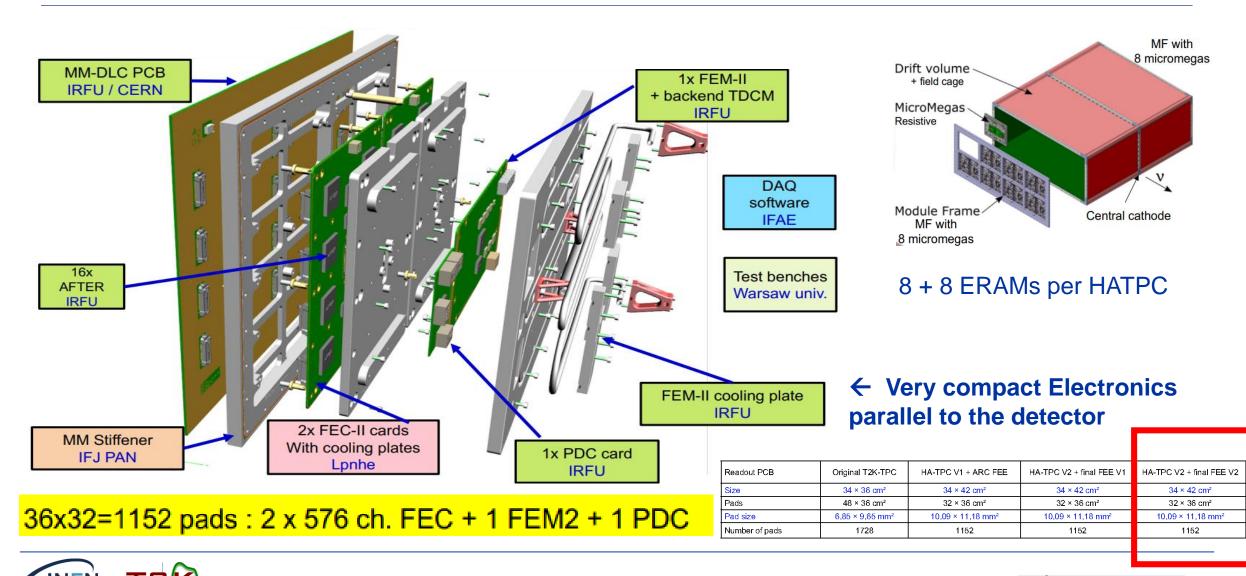






ERAM Module breakout

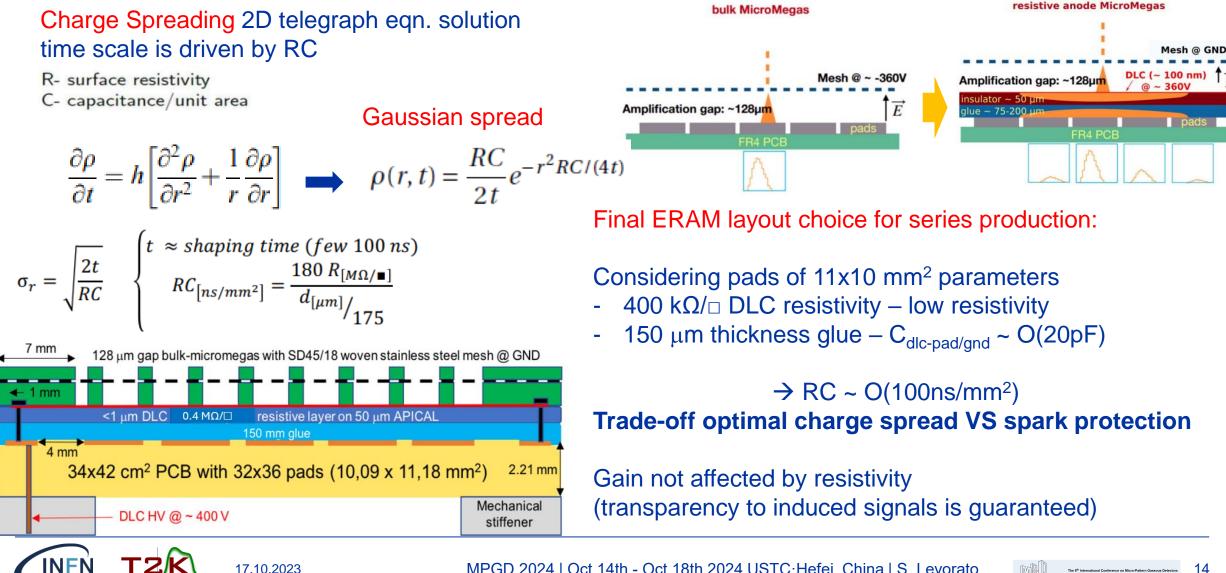
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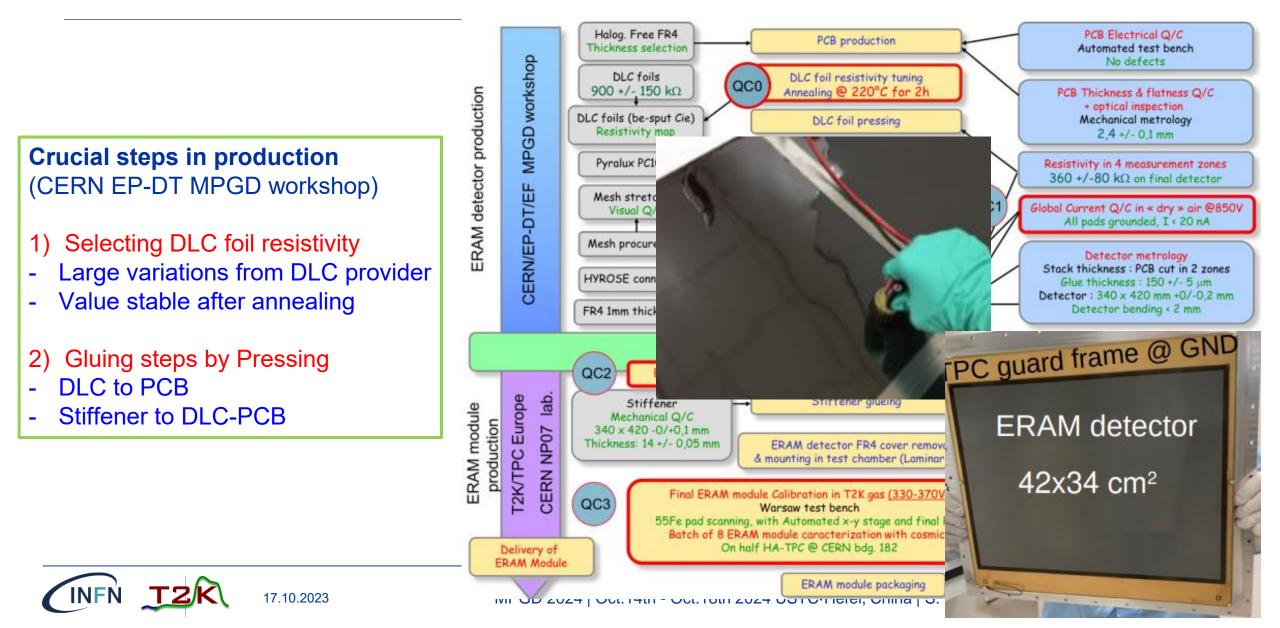
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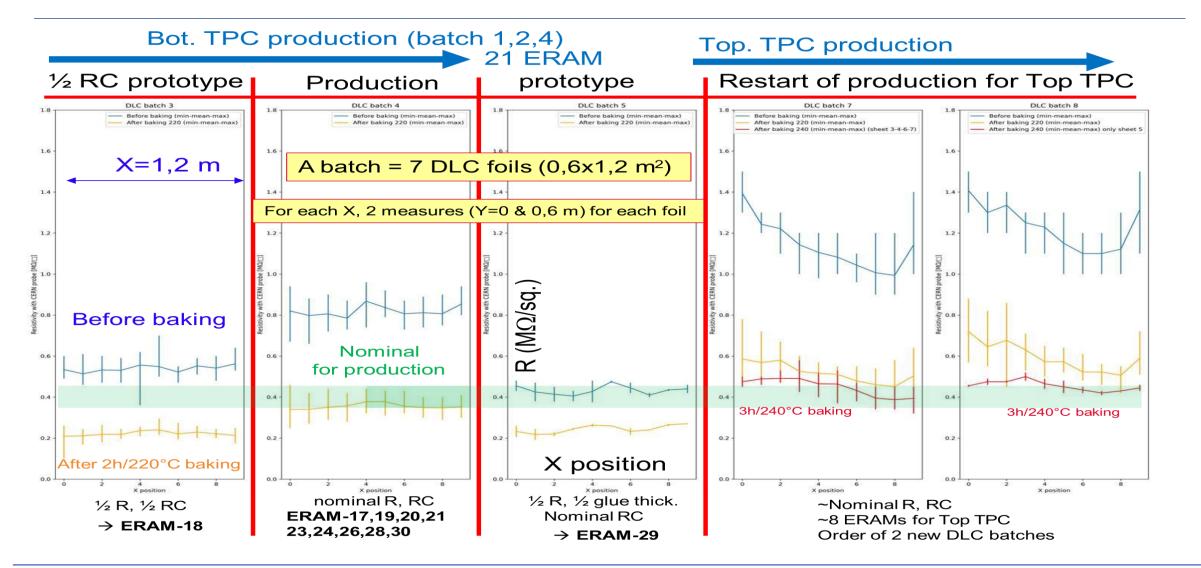
Charge spread on low resistivity foil



ERAM production ~ 50 detectors



DLC layer: foil selection, QC





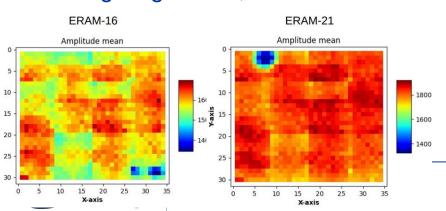


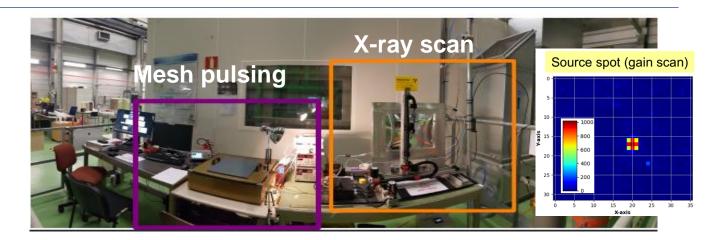
ERAM Series production experience: X-ray scan

X-rays Test Bench at CERN fundamental to

- 1) Qualify, characterize and calibrate all prototypes and series ERAMs
- 2) Support the development of detailed ERAM response model

A) Mesh Pulsing: before and after stiffener gluing
 Aim: detector geom defects (i.e. pillar detach), stiffener gluing issues, electronic noise

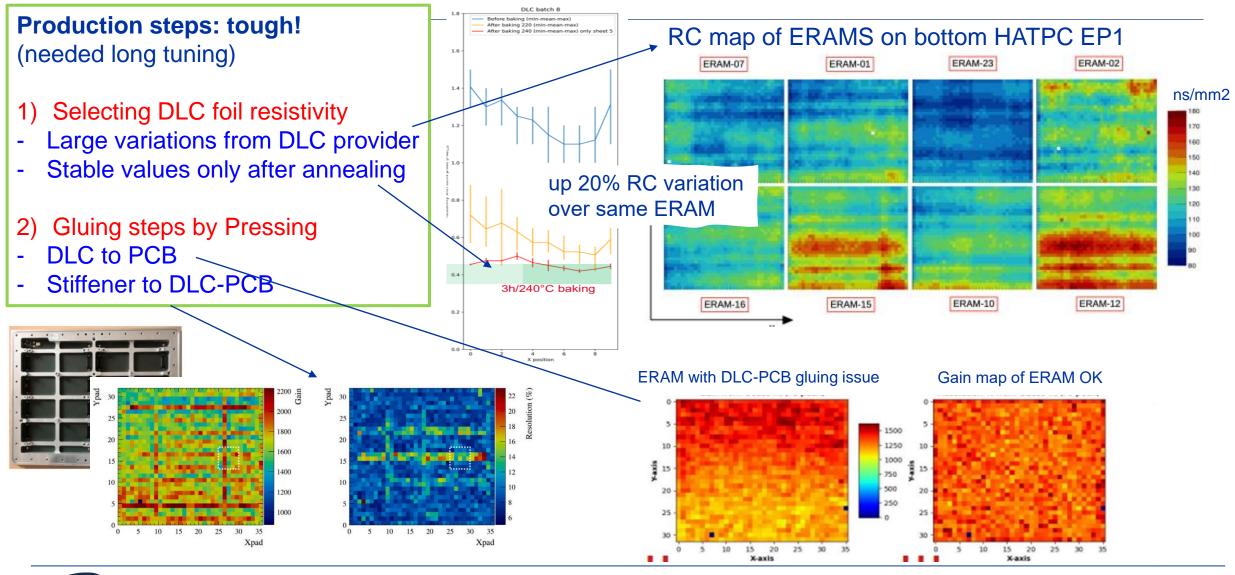




B) X-ray scan of finalized detectors with final electronic modules. Remote controlled station for scanning with mm step fine steps
 Aim: QC and fine calibration in terms of gain, resolution and RC

RC map of ERAM30 RC map

ERAM Series production experience: X-ray scan

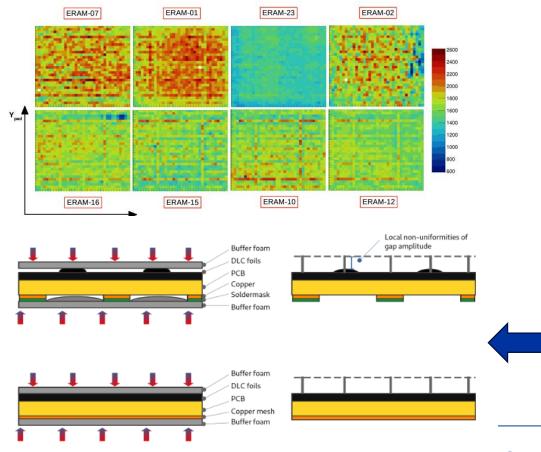


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1µm mesh-DLC gap variation => 10% variation in gain a | S. Levorato

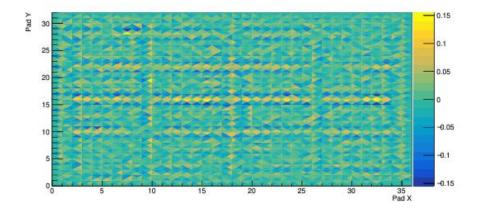
ERAM Series production experience: X-ray scan the importance of the (fast) QA

Gain maps of eight ERAMs tested together in a field cage prototype



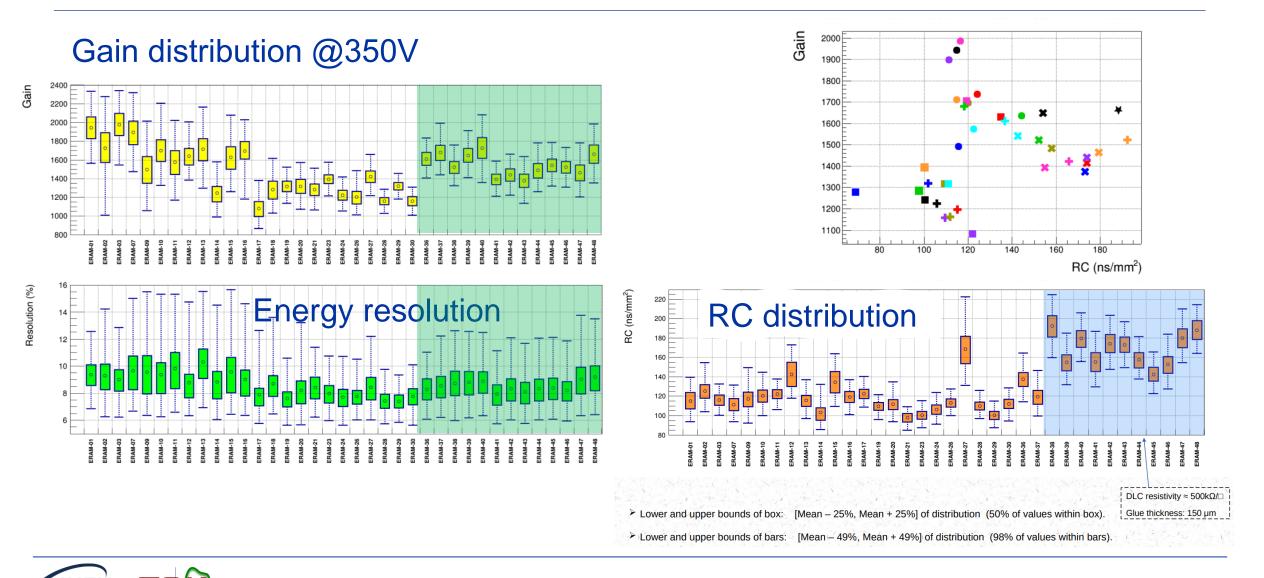
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A map of gain non-uniformity within a pad. relative shift of the mean amplitude reconstructed in the top, bottom, left or right region of each pad under study w.r.t mean amplitude of the pad



DLC pressing on the PCB during detector assembly resulting in the non-uniformities observed on the 2D gain and energy resolution maps
→ The solder mask is removed and replaced by the copper mesh.

ERAM Series production: a summary table



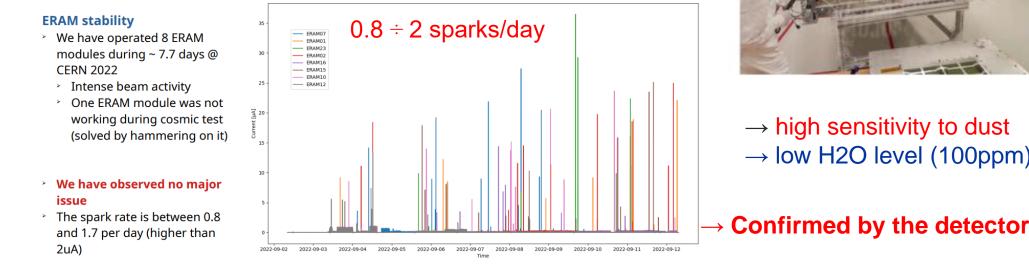
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ERAM Assembly and Operation experience

Low resistivity DLC O(~500k Ω / \Box) [after annealing] features

- Optimal charge spread \rightarrow uniform response across pad (combined with C ~ $O(20pF/cm^2)$)
- Fast Q removal and Effective Protection against sparks included at moderate rates ~ O(1kHz) tracks crossing pads
- Leakage currents at level of few nA in normal conditions (no beam)

ERAM @ test beam 2022



Challenging installation conditions



ERAM assembly (and storage) in Clean Room

revitent area in front of Clean



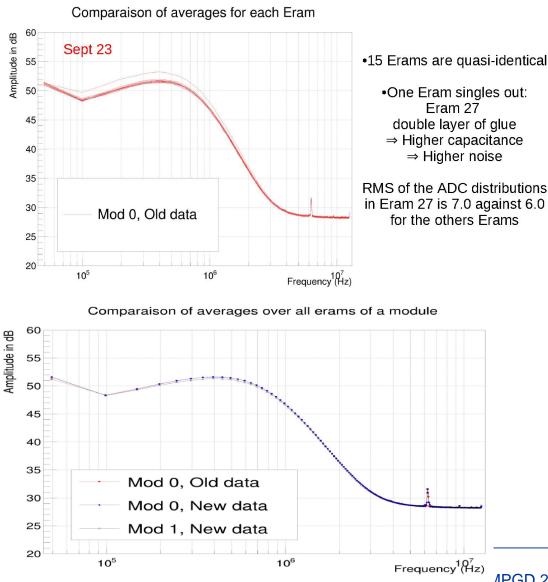
 \rightarrow low H2O level (100ppm) before HV on

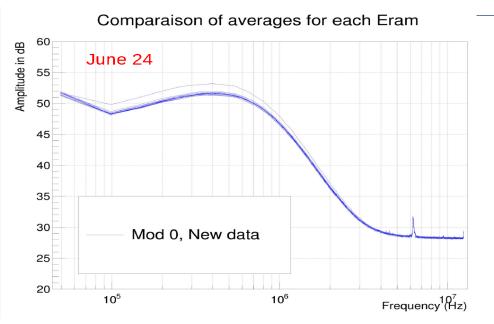
\rightarrow Confirmed by the detector operation at T2K

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Noise: stability of the installed detector





Noise in module 0 has been stable between September 23 and June 24

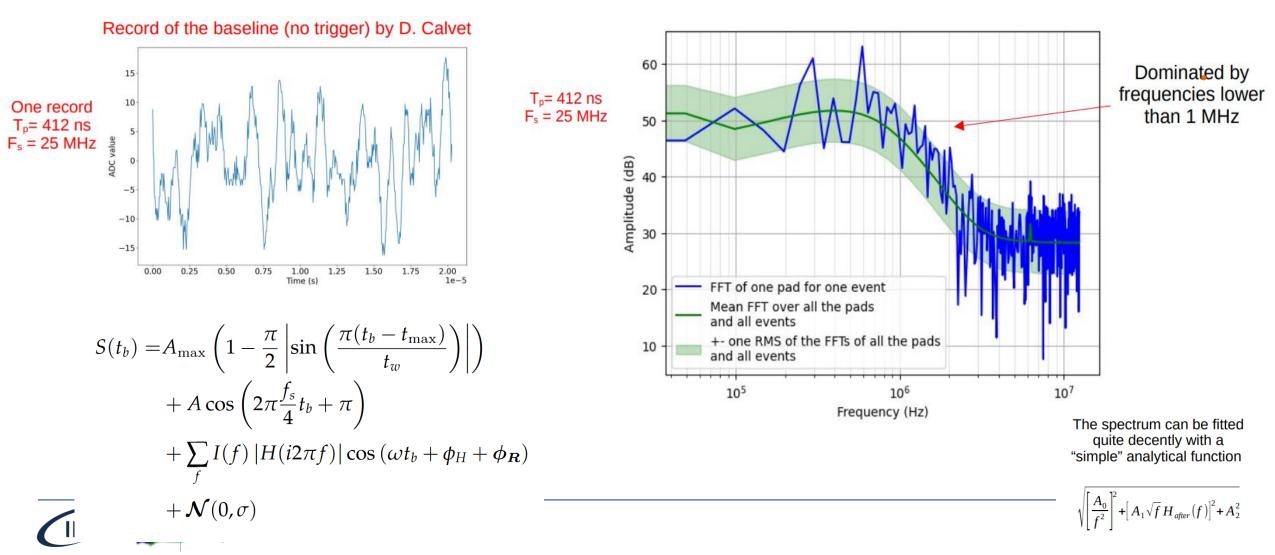
All the Erams are quasi-identical but one, Eram 27, due its higher capacitance

 \rightarrow the excellent uniformity of the electronics and of the mechanical definition of the glue layer driving the detector capacitance

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ERAM detector response – Noise model

Previous conclusions supported by the noise detailed model included in the MC for Simulation of charge deposition in events



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The ND280 experiment: High Angle TPC highlights

How does the signal look ? Point deposition for example

Signal amplitude (ADC) Electronics response Charge deposited punctually Waveform sum 2000 eading pad Wf on a pad (X ray) 1st neighbour Wf 2st neighbour Wf 3rd neighbour Wf 1500 1000 500 ADC signal : max 4096 counts Time window of 511 time bins Time bin (typ.): 40 ns (25 MHz sampling) Peaking time (typ.): 412 ns 180 200 220 160 240 260

Leading pad: highest and earliest signal

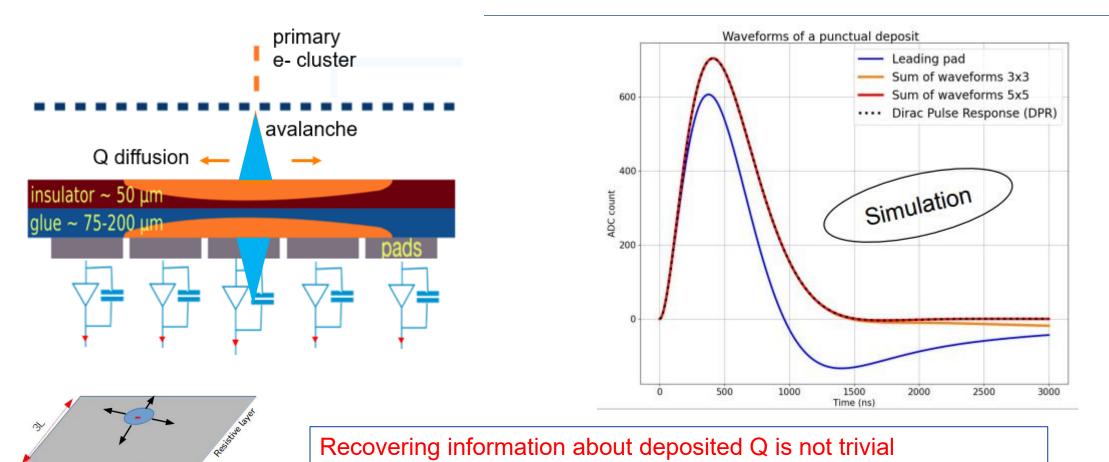
⇒ current induced on pads from by avalanche, ie <u>ions</u> signal (as electrons' signal is too fast)
 Adjacent pads: lower and later signals
 ⇒ current induced by potential field adjustments after <u>electrons</u> are collected by on DLC (current induction by "charge spread on resistive layer")

time bins (40ns)

Reconstruction of charge deposition 1/2

Electronics

3

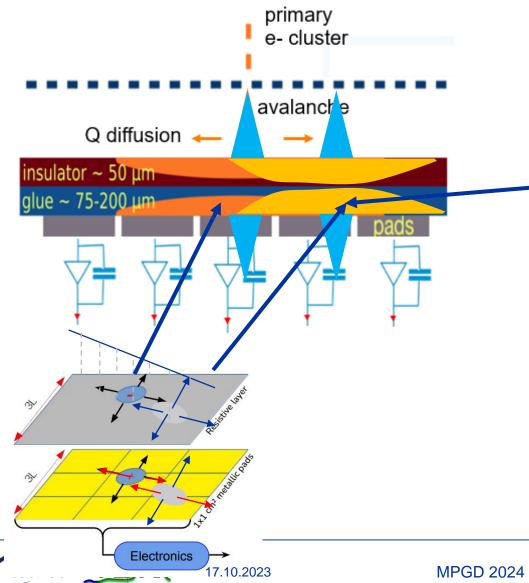


Within our electronics shaping time scale in primary pads, the <u>signal of ions</u> is *diluted* by the <u>signal of charge spreading</u> => Need to combine information of all pads (primary and secondary)

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Reconstruction of charge deposition 2/2



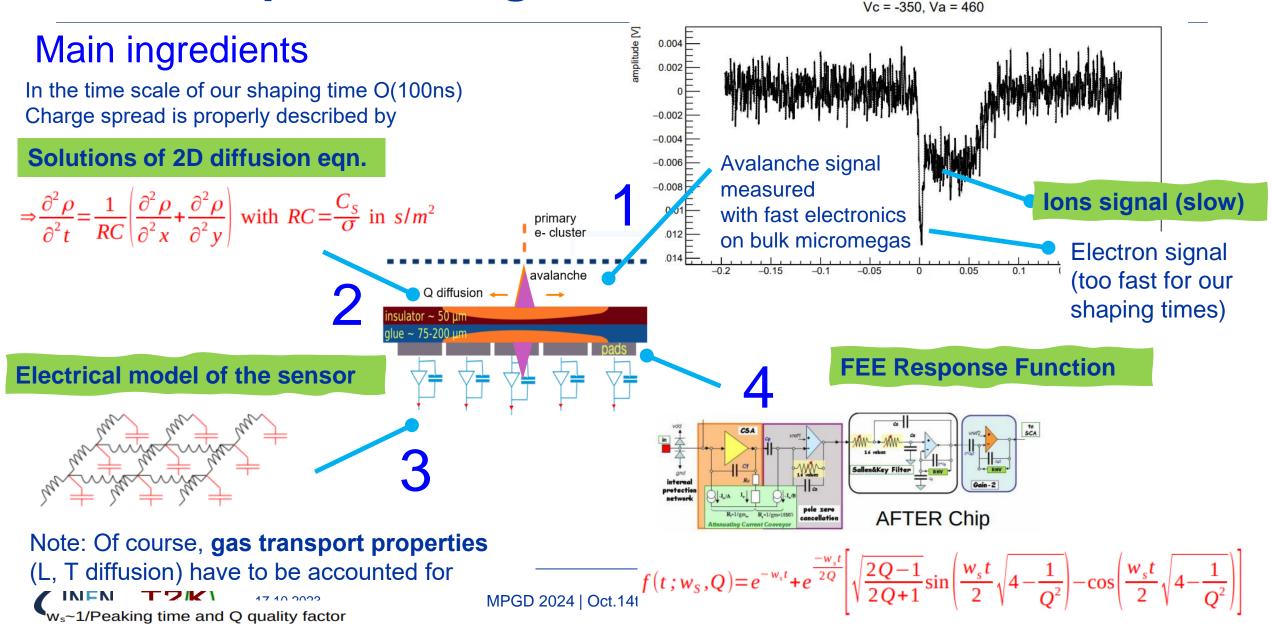
Charge on DLC spreads along any direction including track direction **«longitudinal correlation»** across primary pads within our electronics shaping time scale



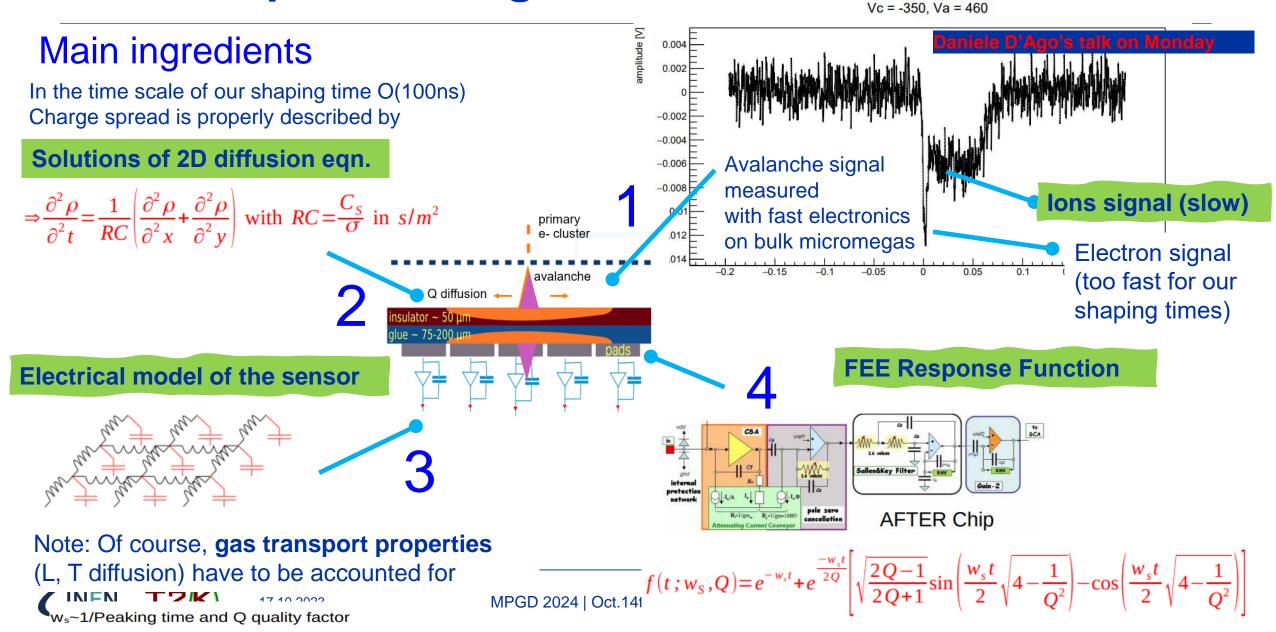
requires a dedicated signal formation model



ERAM response – Signal formation model



ERAM response – Signal formation model



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ERAM detector response: impact on reconstruction

Use of the model for Reconstructing the charge deposition

Due to square shape of ERAM pads, the classical method (PRF+clustering) works OK only for tracks with horizontal or vertical direction (wrt pads coordinates)

Better methods use solutions of telegraph equation in order to

- 1) compute the pattern templates for charge diffusion on DLC
- 2) calculate the overall expected signal waveform per each pad
- 3) find the best matching with the recorded waveforms

Its computationally heavy → different approximations are used for different analysis

1) X-rays analysis – ERAM characterization

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- 2) Measurement of dE/dx Particle Identification
- 3) Track reconstruction momentum measurement



Reconstructing X-rays charge deposition

Q_{pad}(t) = Solution of 2D Teq. for diffusion of initial Q deposited charge (point-like, delta-pulse initial conditions)

 $RC = 60 \text{ ns/mm}^2$

 $Q_{2} = 4 e^{-1}$

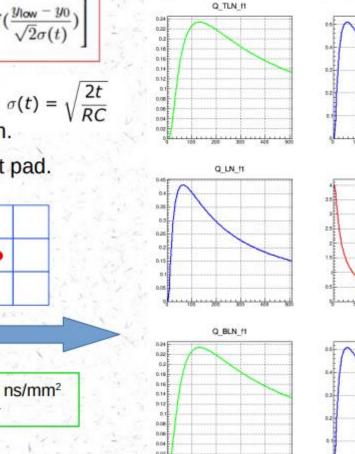
$$Q_{pad}(t) = \frac{Q_e}{4} \times \left[erf(\frac{x_{\mathsf{high}} - x_0}{\sqrt{2}\sigma(t)}) - erf(\frac{x_{\mathsf{low}} - x_0}{\sqrt{2}\sigma(t)}) \right] \times \left[erf(\frac{y_{\mathsf{high}} - y_0}{\sqrt{2}\sigma(t)}) - erf(\frac{y_{\mathsf{low}} - y_0}{\sqrt{2}\sigma(t)}) \right]$$

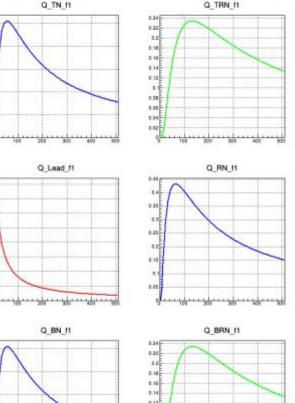
- Obtained from Telegrapher's equation for charge diffusion.
- Integrating charge density function over area of 1 readout pad.
- Parameterized by 5 variables:
 - x_0 • y_0 Initial charge position
 - t_o: Time of charge deposition in leading pad

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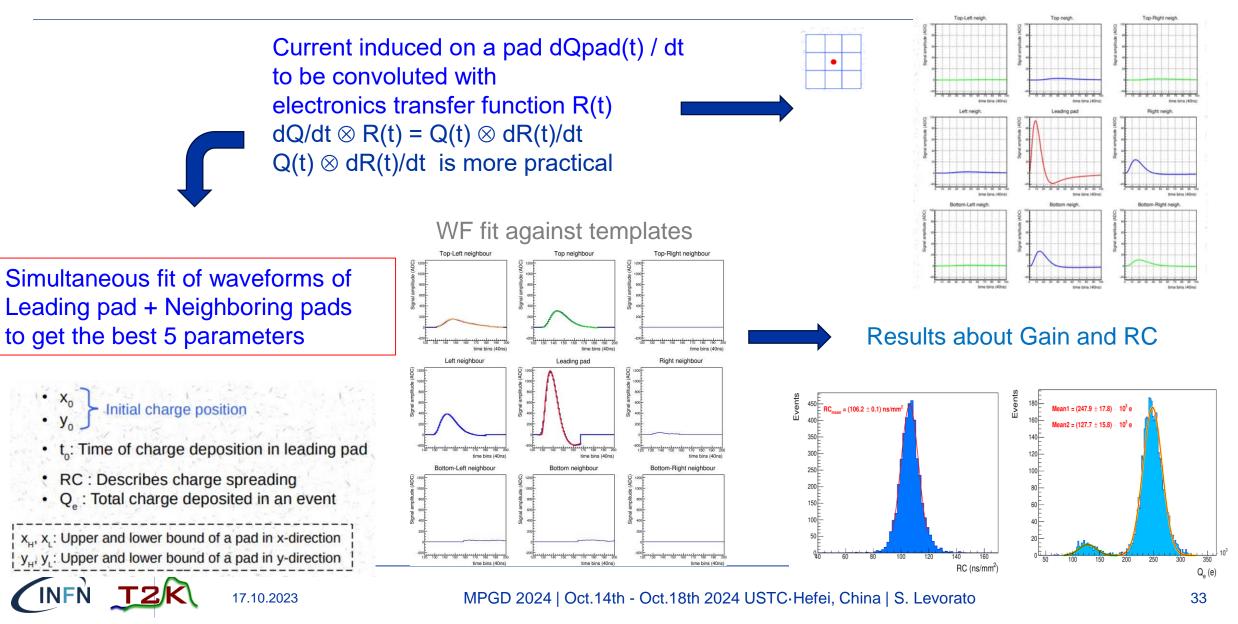
- RC : Describes charge spreading
- Q_e: Total charge deposited in an event

 x_{H}, x_{L} : Upper and lower bound of a pad in x-direction y_{H}, y_{L} : Upper and lower bound of a pad in y-direction

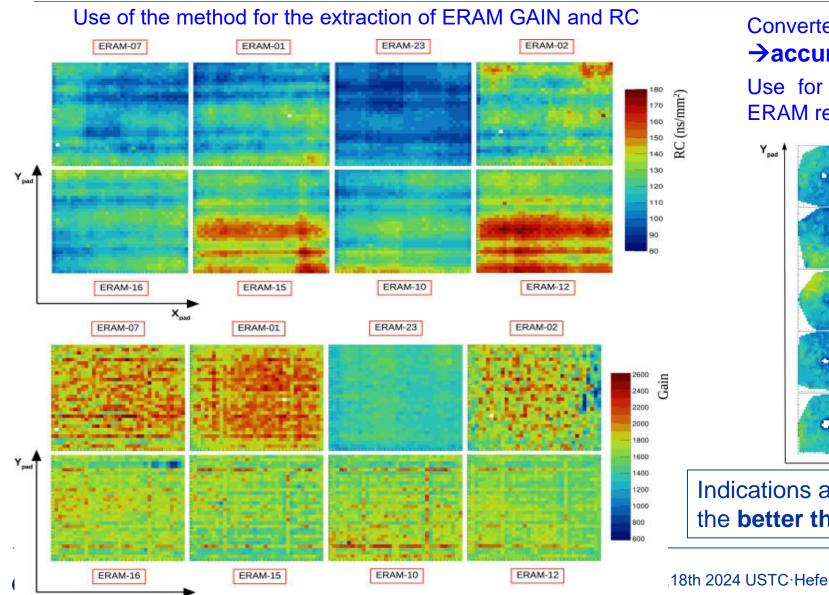




Reconstructing X-rays charge deposition WF templates

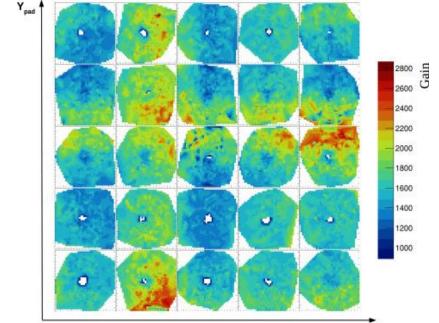


Extraction of RC and Gain maps from X-rays



Converted X-ray impact point position is also fitted →accurate maps of Gain and RC

Use for detailed studies of charge diffusion and ERAM response at fine PAD position level



Indications are that the lower resistivity the better the performance (eg space resolution)

Reconstructing Q along tracks

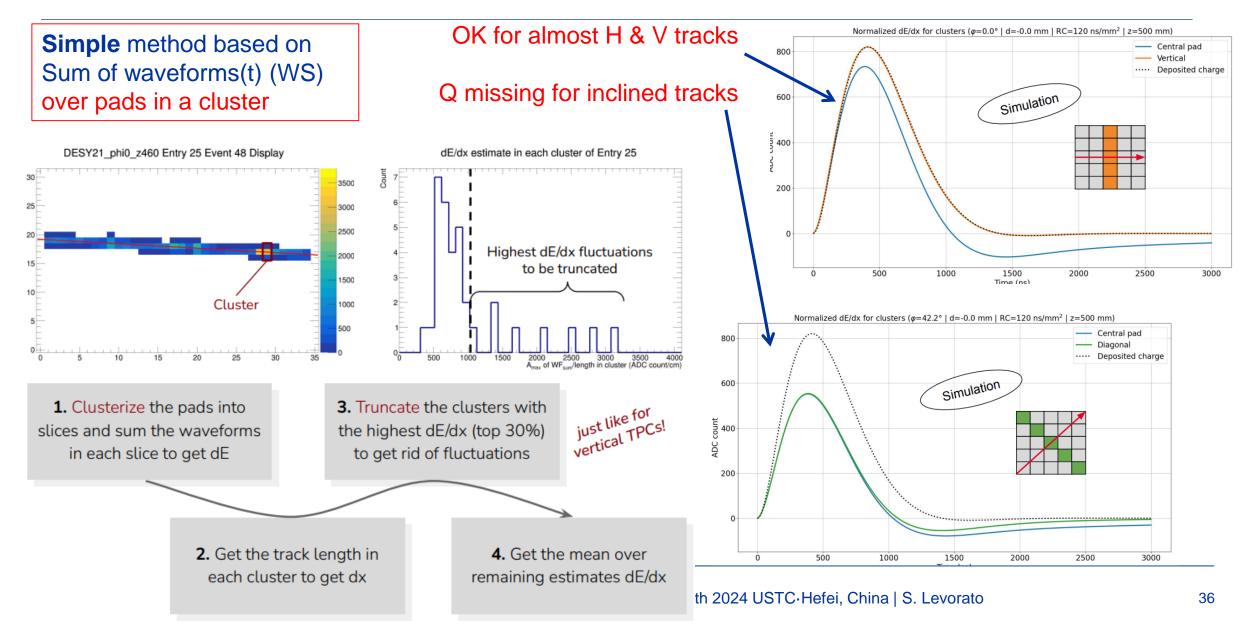
For the reconstruction of the charge along the tracks two methods

- Waveform Sum (WS)
- Crossed Pad (XP)

Compare the performance of the two methods for dE/dx extraction



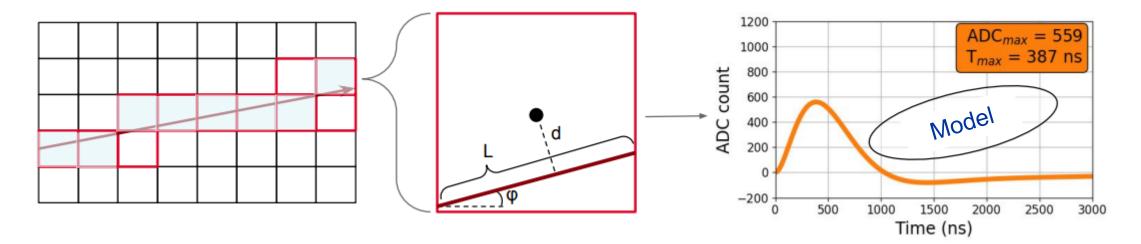
Reconstructing Q along tracks: Waveform Sum



Reconstructing Q along tracks: Crossed Pad (XP)

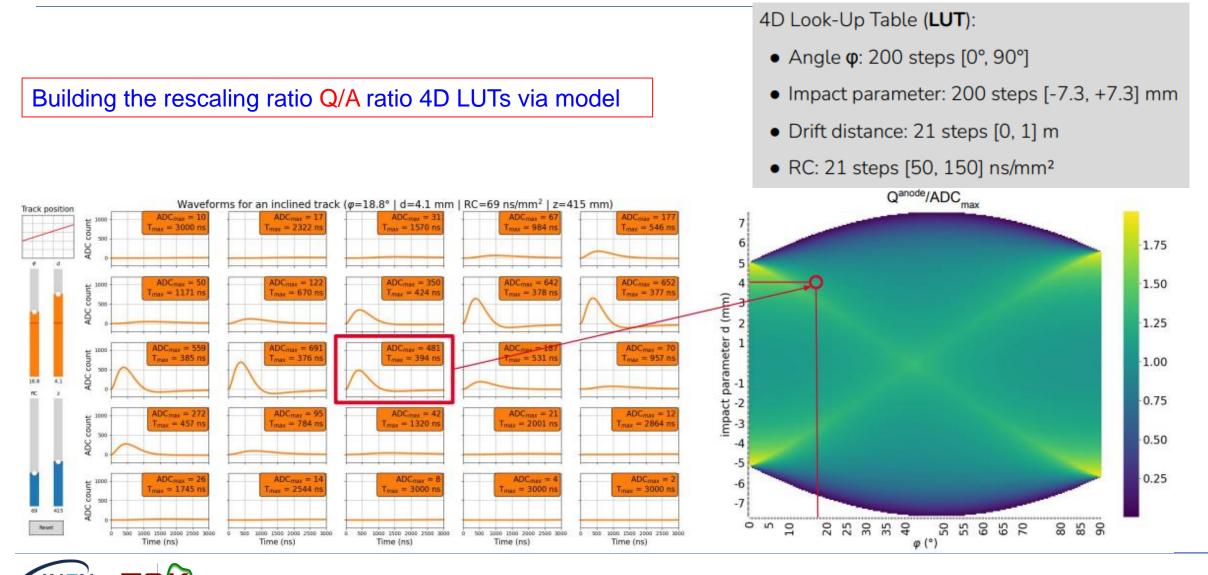
- 1) Reconstruct tracks and consider only pads crossed (XP) by the track (primary pads)
- 2) Reconstruct original (ion induced) charge (Q) for each XP (given the track parameters there)
 - by $Q = A \times (Q/A)$ where A is recorded amplitude on XP and rescaling ratio (Q/A) from Look Up tables (LUT)

LUTs build from model: original Q is distributed linearly over the segment for each XP so that solutions of diffusion equations can be used



No clustering => potentially more accurate method because reconstructing full induced charge on primary pads
 «dilution of ion signal» on a XP pad, due to charge spread over the pad is correctly taken into account
 «longitudinal correlation» among adjacent XP pads, due to charge spread along track direction is accounted for
 Fast method though based on model templates (long time is to generate LUTs ...)

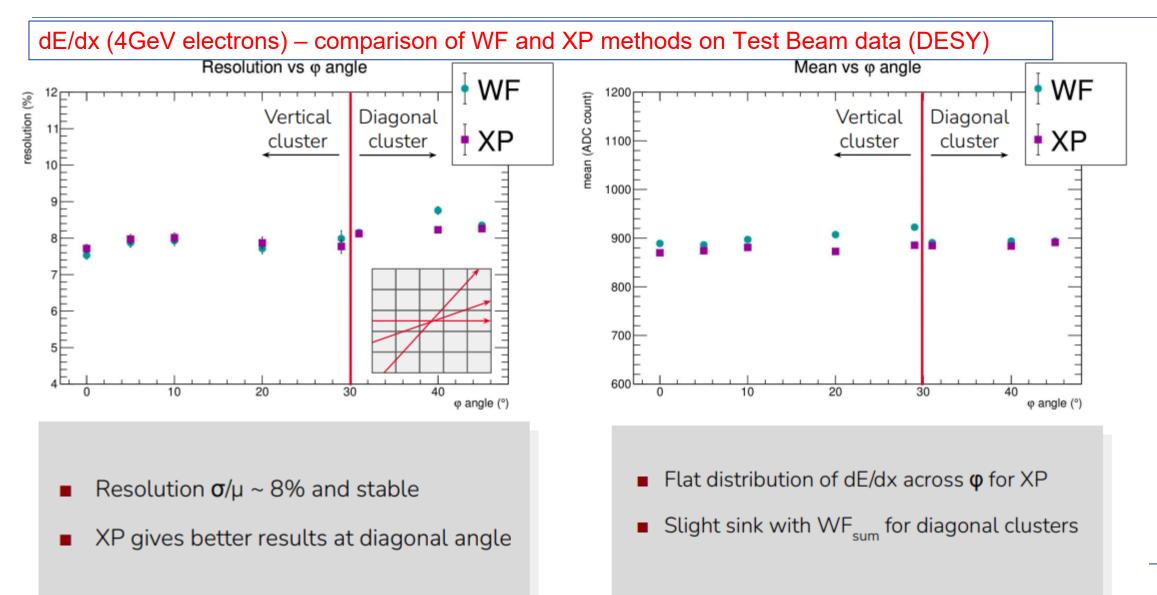
Reconstructing Q along tracks: Crossed Pad (XP)



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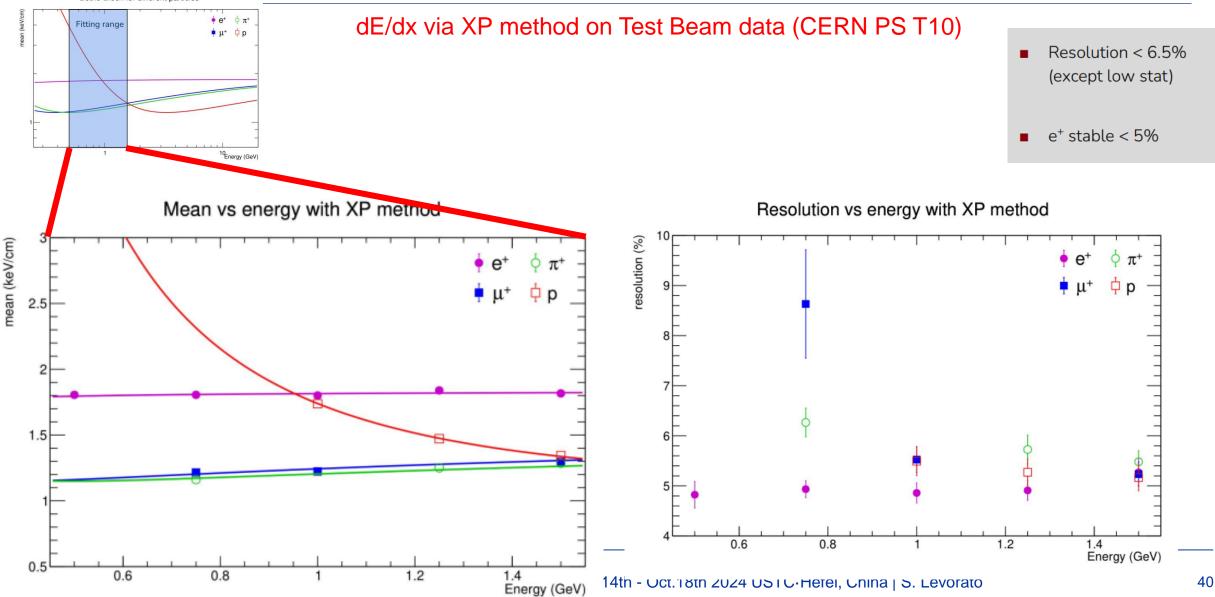
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dE/dx preliminary results: (WS) and (XP) methods



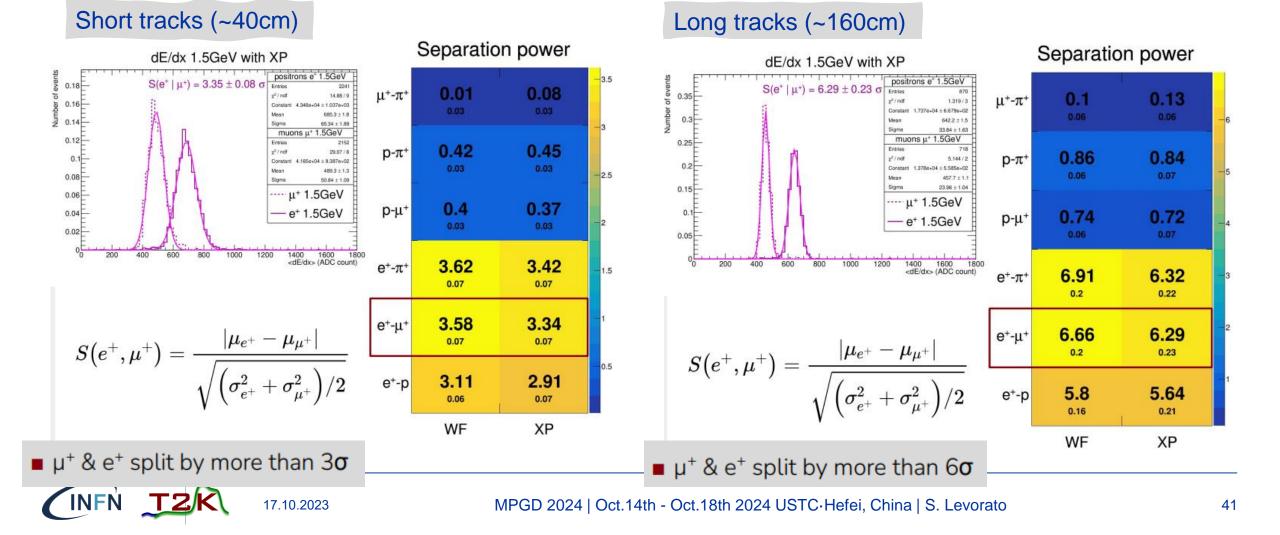
dE/dx preliminary results: (XP) method

Bethe-Bloch for different particles



PID preliminary results (XP) vs (WS)

e/μ separation @ 1.5 GeV – Test Beam data (CERN PS T10)



Reconstructing tracks

For the reconstruction of the tracks

Log(Q) methods

Full Waveform fit Method



Reconstructing tracks, trajectory fitting: an example

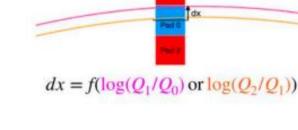


- logQ method to reconstruct position in each cluster
- Helix fit performed on those reconstructed positions

Full Waveform fit Method – based on model & no clustering

- 1) Use all the pads associated to a track (Q_{max} values) to define a (v,u) local frame
- 2) Distribute "arbitrary" point charges along v axis separated by Δv (5mm) the Q per each point is a free parameter
- 3) Diffusion model to predict the waveform generated by point charges in surrounding pads

4) Move all points along the u axis to minimize the chi-square difference between measured waveforms and templates \rightarrow extract the coordinates $\chi^2 = \sum \sum \frac{Q_i}{Q_i}$



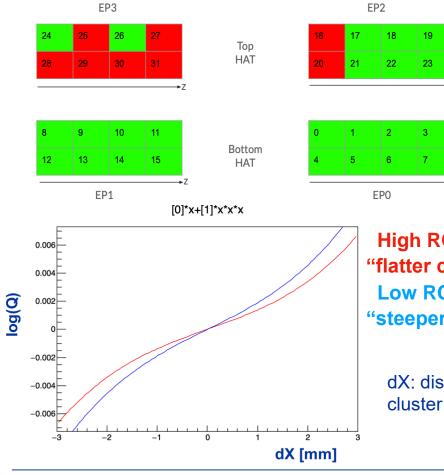
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i(*pad*) *i*(*timebin*)



Spatial resolution: the importance of the QA

Top HAT was equipped with ERAMs with larger RC variation w.r.t. Bottom



High RC → less charge spreading "flatter curve" Low RC → more charge spreading

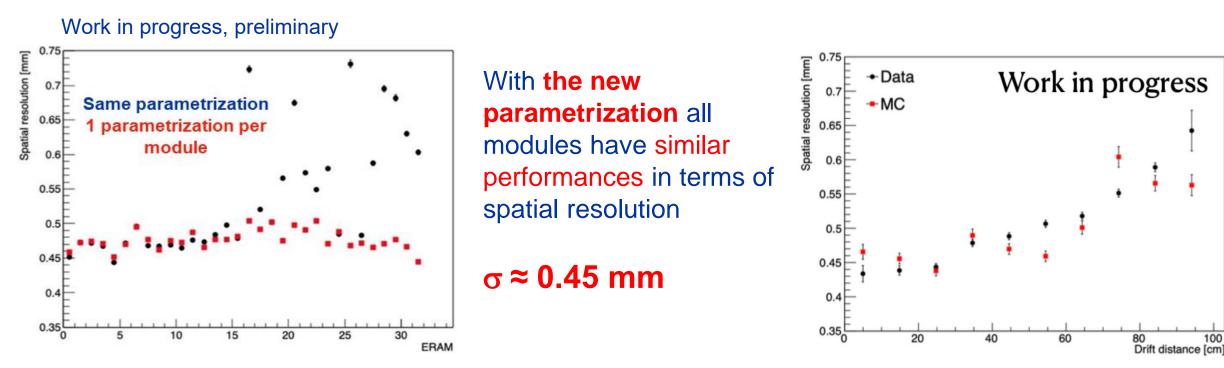
"steeper curve"

dX: distance from the center of the cluster and the real position

Non negligible RC variation among the same Endplate of the TPC

Need to tune the log(Q) parametrization \rightarrow ERAM dependent....

Spatial resolution after reparameterization

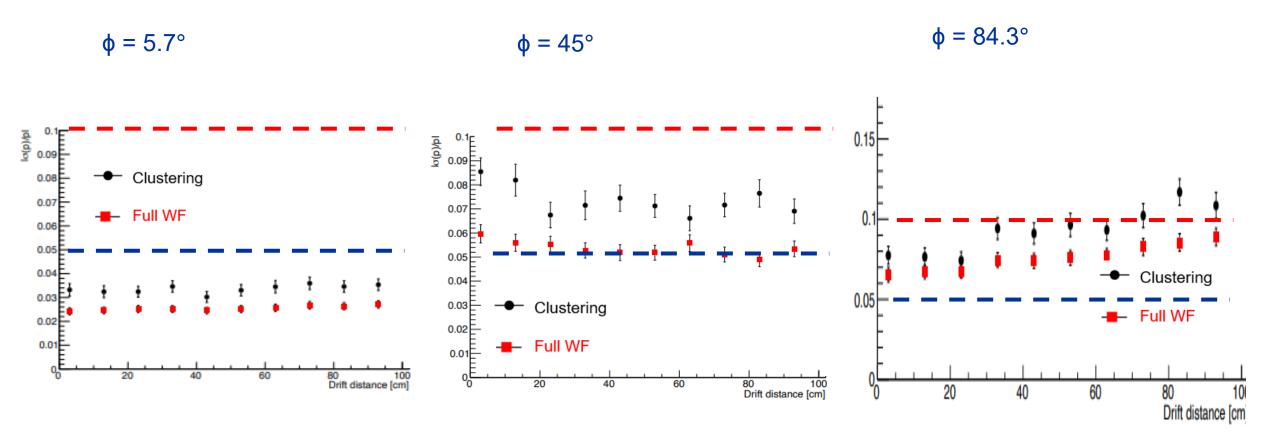






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Reconstructing tracks: momentum resolution



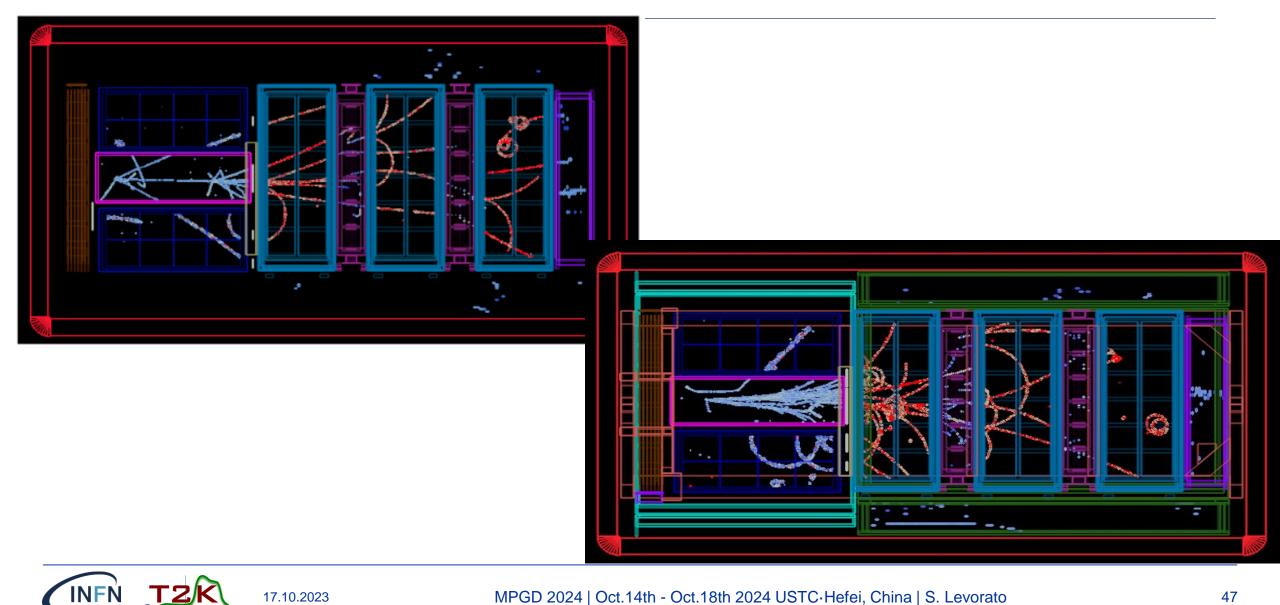
 $\sigma_{\rm p}$ /p momentum resolution as a function of track drift distance: simulated 700 MeV/c muons

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Event display, full ND280 detector!



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Conclusions

Two new TPCs have been just installed in ND280 at JPARC

- Very stable operations in commissioning and technical runs
- Firs Neutrino Data taking just completed, restarting now !

Resistive MM with encapsulated anode **ERAM**

- First time use of an encapsulated resistive Micromegas in a High Energy running experiment
- Low resistivity & optimal charge spread & no sparks effects
- Series production allowed several detailed studies
- The ERAM technology is complex and delicate to produce as are all the resistive MPGDs. The expertise and excellent partnership with the CERN/PCB workshop enabled a high yield (~80%) of high-quality production
- New algorithms for square pads exploiting detailed response model under development
- Detector performance, still preliminary but very promising!





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Thanks!

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Just in Case



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- The goal of Long Baseline neutrino experiments:
- ✓ Remaining problems: CP symmetry, Mass ordering, Octant of θ_{23}
- ✓ Precise measurements of θ_{23} , $|\Delta m^2_{31}|(\sim |\Delta m^2_{32}|)$

• Muon neutrino disappearance
$$(\nu_{\mu} \rightarrow \nu_{\mu})$$
:
 $P(\nu_{\mu} \rightarrow \nu_{\mu}) \approx 1 - (\cos^2 \theta_{13} \sin^2 2\theta_{23}) \sin^2 \left(\Delta m_{32}^2 \frac{L}{4E_{\nu}}\right)$
Sensitive to:
 $\theta_{23}, \left|\Delta m_{31}^2\right| \left(\sim \left|\Delta m_{32}^2\right|\right)$

• Electron neutrino appearance ($\nu_{\mu} \rightarrow \nu_{e}$) :

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$$P(\nu_{\mu} \rightarrow \nu_{e}) \approx \sin^{2} \theta_{23} \sin^{2} 2\theta_{13} \sin^{2} \left(\frac{\Delta m_{32}^{2} L}{4E_{\nu}}\right) \left(1 + \frac{2a}{\Delta m_{31}^{2}} \left(1 - 2\sin^{2} \theta_{13}\right)\right)$$

$$Sensitive to:$$

$$\theta_{13}, \delta_{CP}, \theta_{23}, \text{and}$$

$$-\sin 2\theta_{12} \sin 2\theta_{23} \sin 2\theta_{13} \cos \theta_{13} \sin \delta \sin^{2} \left(\frac{\Delta m_{32}^{2} L}{4E_{\nu}}\right) \sin \left(\frac{\Delta m_{21}^{2} L}{4E_{\nu}}\right)$$

$$Mass ordering \Delta m_{31}^{2}$$

• $P(\bar{\nu}_{\mu} \rightarrow \bar{\nu}_{e})$: δ turns into – δ and a to -a ("a" matter effect term)

Reconstructing tracks: trajectory fitting



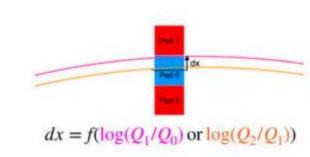
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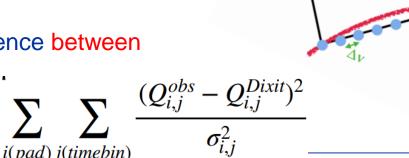
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1) Use all the pads associated to a track (Qmax values) to define a (v,u) local frame

- 2) Distribute "arbitrary" point charges along v axis separated by Δv (5mm) the Q per each point is a free parameter
- 3) Diffusion model to predict the waveform generated by point charges in surrounding pads

4) Move all points along the u axis to minimize the chi-square difference between measured waveforms and templates RungeKutta method to fit (u0, du/dv, q/p, t₀, dv/dt) $\chi^2 = \sum \sum_{i=1}^{n} \frac{(i-1)^{i-1}}{2} \sum_{i=1}^{n-1} \frac{(i-1)^{i-1}}{2} \sum_{i=1}^{n-1$







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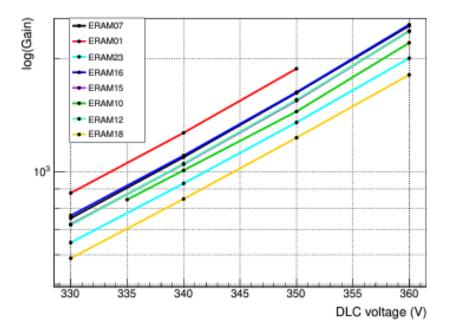
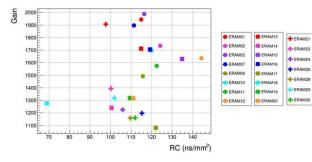


Figure 28: Comparison of gain extracted using the waveform sum and simultaneous fit methods for all the analyzed ERAMs.



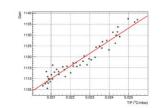


Figure 37: Effect of T/P on the gain of one pad. The lowest value of (T,P) recorded during the scan was (19.8 °C, 959.5 mbar) and the highest value was (24.5 °C, 963.7 mbar).

Figure 29: Dependence of mean RC on mean gain of all the analyzed ERAMs.

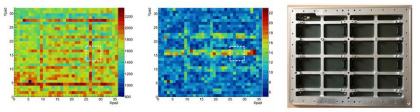
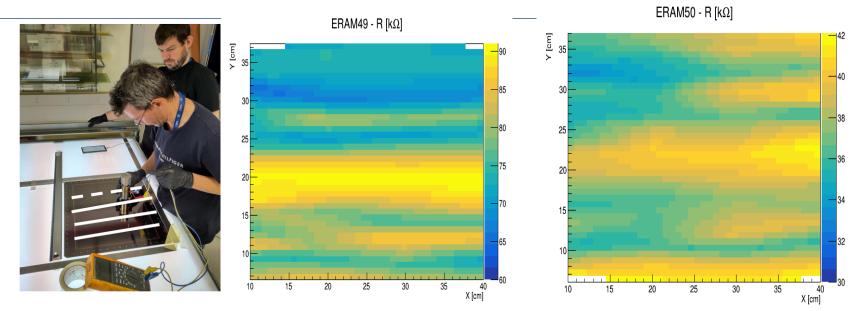


Figure 30: Left: 2D map of the relative gain in ADC of the ERAM-10 module; Middle: 2D map of the energy resolution in % of the ERAM-10 module; Right: PCB top layer: the grey area are 20-35 μ m thick copper + 50 μ m soldermask while the cross hatched area is made of copper mesh only.

Readout PCB	Original T2K-TPC	HA-TPC V1 + ARC FEE	HA-TPC V2 + final FEE V1	HA-TPC V2 + final FEE V2
Size	34 × 36 cm²	34 × 42 cm ²	34 × 42 cm ²	34 × 42 cm ²
Pads	48 × 36 cm²	32 × 36 cm²	32 × 36 cm²	32 × 36 cm²
Pad size	6,85 × 9,65 mm²	10,09 × 11,18 mm ²	10,09 × 11,18 mm ²	10,09 × 11,18 mm ²
Number of pads	1728	1152	1152	1152

Detailed R measurement (dedicated probe)

A dedicated probe has been built to perform a fine measurement of the surface resistivity.

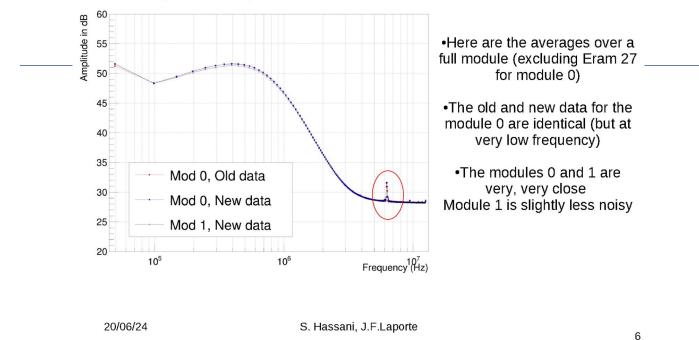


Will be soon complemented with the comparison with the data extracted from X-ray analysis

R **inhomogeneities** in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.



Comparaison of averages over all erams of a module



(6.3)

(6.4)

- The term 6.1, identified as the low-frequency fitting of the deterministic contribution (Section 5.3.4, Fig. 5.6). The form of the equation ensures that the mean is 0. Additionally, A_{max} controls the maximum amplitude, and t_{max} determines its position.
- The term 6.2, represents the high-frequency adjustment of the deterministic contribution (Section 5.3.5, Fig. 5.6) is represented by a simple $cos(f_n)$ with a frequency of $\frac{f_s}{4}$. The amplitude is adjusted using the parameter A.

$$S(t_b) = A_{\max} \left(1 - \frac{\pi}{2} \left| \sin \left(\frac{\pi (t_b - t_{\max})}{t_w} \right) \right| \right)$$

$$+ A \cos \left(2\pi \frac{f_s}{4} t_b + \pi \right)$$
(6.1)
(6.2)

$$+\sum_{f} I(f) |H(i2\pi f)| \cos \left(\omega t_b + \phi_H + \phi_R\right)$$

 $+ \mathcal{N}(0, \sigma)$

 The term 6.3, describe the AFTER chip contribution (Section 5.2), which is the response of the electronics to the random current:

$$I(t) = \sum_{f} I(f) \cos\left(\omega t + \phi_{\mathbf{R}}\right)$$

because for a signal such as :

 $\mathbf{I}(t) = I_0 \cos\left(\omega t\right)$

the electronic response is by definition of the Transfer Function:

$S_{elx}(t) = I_0 \left| H(i2\pi f) \right| \cos\left(\omega t + \phi_H\right)$

where $|H(s = i2\pi f)$ and Φ_H are the norm and the phase of the transfer function (cf Fig. $\overline{8.2}$).

• The term 6.4, we refer to the white noise (Section 5.4), which is represented by Gaussian distribution added for each time bin.



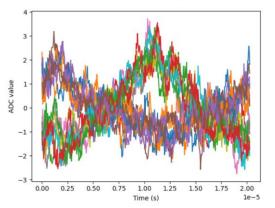
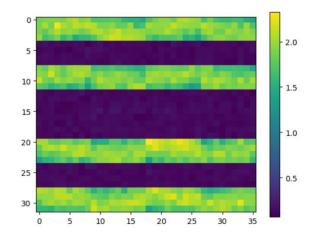


Figure 5.3: Mean waveforms of few pads in the ERAMs, averages over all events

As is clear from the Fig. 5.3, there is two typologies of the mean waveform. It has been shown that these two types correspond to two populations of pads positioned on the ERAMs as shown on Fig. 5.4.



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Conclusions

Two new TPCs have been just installed in ND280 at JPARC

- Very stable operations in commissioning and technical runs
- Firs Neutrino Data taking just completed, restarting in October 2024

Field cages

- High ratio active/passive volume
- Highly effective insulation & E field uniformity
- Composite material technology exploited at the limit of the technology

Resistive MM with encapsulated anode

- Low resistivity & optimal charge spread & no sparks effects
- Series production allowed several detailed studies
- The ERAM technology is complex and delicate to produce as are all the resistive MPGDs. The expertise and excellent partnership with the CERN/PCB workshop enabled a high yield (~80%) of high-quality production
- New algorithms for square pads exploiting detailed response model under development

HATPC: features, challenges, constrains and solutions

Mechanics and Electric Field uniformity

• Min dead space & max active volume in the dipole magnet

→Rectangular shape & thinnest walls & field shaping electrodes incorporated into the walls

- Electric field uniformity better than 10⁻³ @1cm from walls
 - \rightarrow Mechanical accuracy: inner surfaces planarity & parallelism ~ O(0.2mm/m)
 - → Shaping Electrode design: Field and Mirror copper strip layers on two sides
- of a Kapton foil
- Low material budget walls
 - → lightweight & lowest Z & robust (self supporting)

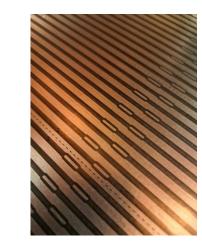
Electrical insulation Constrains

• HV insulation mantle R > 1TOhm and volume resistivity, HV

→geometry: several cm paths for charge from -HV strips to GND shielding (cathode flanges)

→insulating materials: very high resistivity & dielectric strength





HATPC: features, challenges, constrains and solutions

Building process: hand lay-up of composite materials on a Mould & polymerization in autoclave at high Pressure

Autoclave dimensions

→ Field Cage comprising two halves (symmetrical flanges at central cathode position)

• Hand layup & large dimensions

 \rightarrow several hours per process step \rightarrow very long pot life for epoxy resin

• Mechanical accuracy of geometry \rightarrow resin curing at low T < O(40°C)

Materials of choice

- lamination materials: Aramid polymers for peels (Twaron) and for honeycomb (Nomex paper)
- epoxy resin limited choice: Resoltech 1054 combined with quality control against contaminants (moisture, ...)
- high insulation layers: Kapton
- box skeleton material: high quality laminated G10

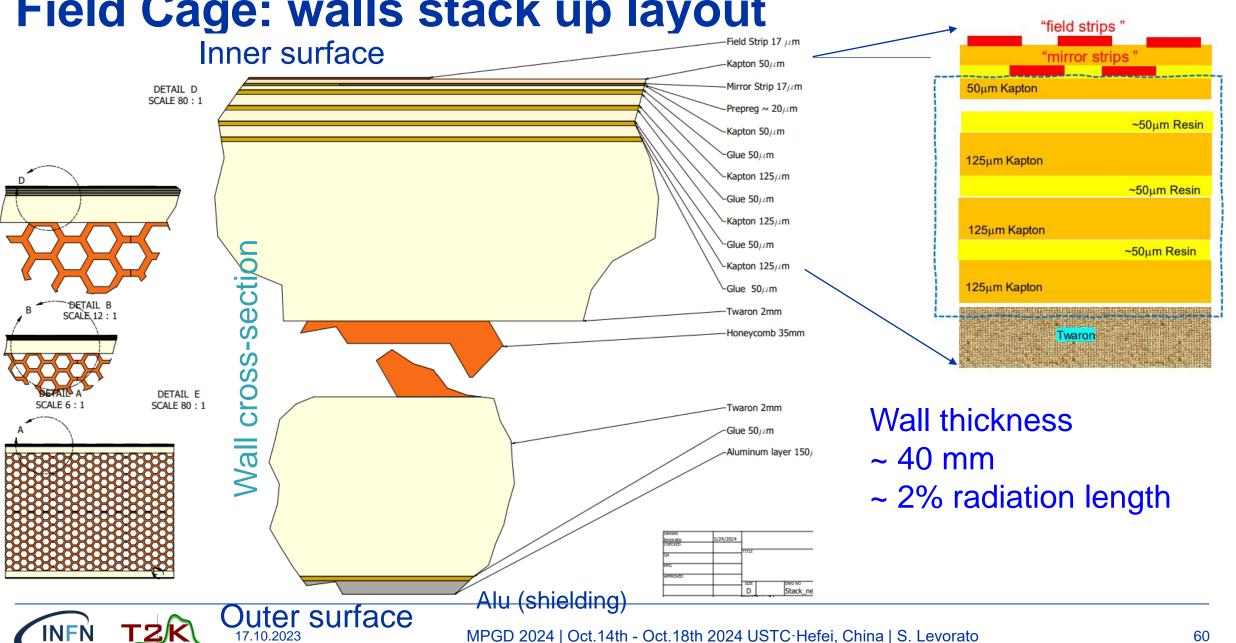




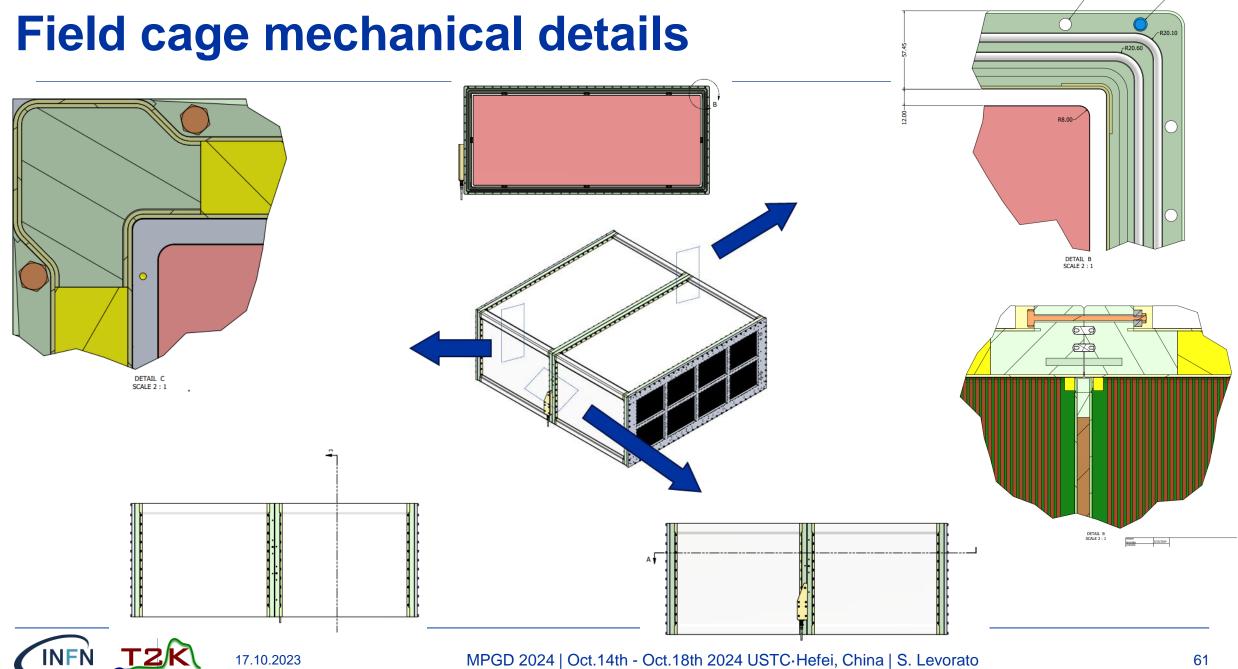
The ND280 experiment: High Angle TPC highlights

- Field Cage (FC)
 - Assembly and layout
 - Production
 - Characterization and Quality Assessment
 - Mechanical
 - Electrical
 - Encapsulated Resistive Anode Micromegas (ERAMS)
 - Production of 50 sensors
 - Characterization
 - Detector response, signal and impact on reconstruction
- Impact on HATPC performance





Field Cage: walls stack up layout



-Ø10.00

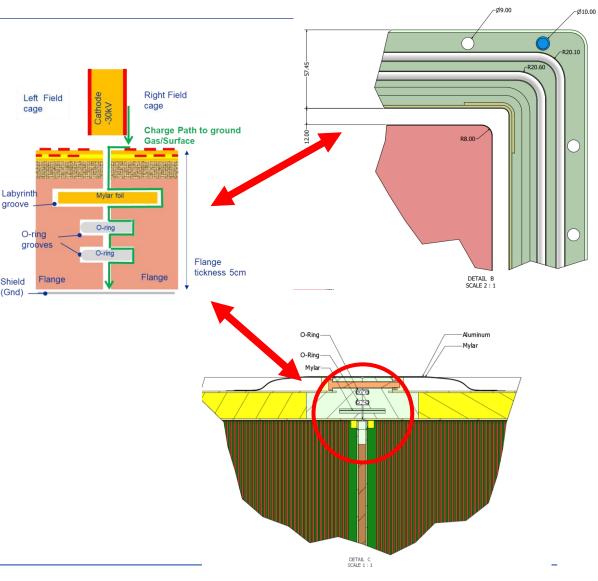
Field cage mechanical details: charge path to gnd

Flange thickness (5cm) too small for degrading -30kV to GND over a flat surface

Three deep grooves for extending the path from HV to GND for charge moving on surface and with gas flanges

- ~ 7cm thick labirinth
- ~14 cm path lenght

 \rightarrow voltage drop / path length < 3kV/cm



The ND280 experiment: High Angle TPC highlights

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Field Cage building, assembling and characterization





•

Field Cage building, assembling & characterization at NEXUS Kapton Layer Production at NEXUS company (Barcelona) ~ 10 weeks

Validation, QC, electrical and mechanical assembly at CERN ~ 4 weeks



5 m perimeter x 1m height (drift length)

- Mold preparation
- Inner Vacuum bag
- Strip Foil positioning

lamination of 3 Kapton layers

Strip foil (by CERN) alignment and



- Kapton lamination
- Curing at 40C (fast)
- Electrical tests on surfaces and resin samples after curing





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Thick corners w/ Kapton tape

Resin samples electrical Tests

Electrical tests on surfaces

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Field Cage building, assembling & characterization at NEXUS Kapton Layer and inner Twaron

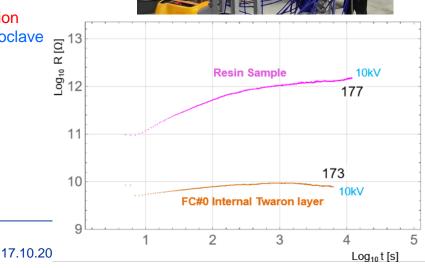
Inner Twaron peel lamination

- First Twaron layer lamination
- Curing at 40C (fast) in autoclave

Electrical tests

Resin sampleInner Twaron layer





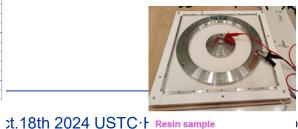
Quality controls - Resistivity of early Layers

1) Resistance between mold and 40x45cm2 electrode -> volume resistivity of layers



3) Resistance between two 6x80cm2 electrodes-> mix of surface and volume resistivity





(Resoltech Epoxy)

2) Surface resistivity of last layer Twaron





- various methods and electrode types (optimizing contact)
 → consistent measurements
- 2) Resin sample ρ_S ~ 10 TΩ/∏ -→ very good γraιο οῦ

Field Cage building, assembling & characterization at NEXUS Kapton Laver + inner Twaron + G10 Skeleton

Callan

17.10.2023

- G10 skeleton gluing
- Curing 40C in clean room

Gluing G10 "skeleton"

Gluing G10 structural skeleton and casting resin on flanges for ensuring gas tightness



Autoclave curing at 40C

Casting low viscosity resin on top flange

 \rightarrow sealing flange to laminated layers

Flanges & Bars

(TV, Italy)

by **ORVIM** company

Field Cage building, assembling & characterization at NEXUS Kapton Layer + inner Twaron + G10 Skeleton + HC + Ext Twaron

- Gluing Nomex Honeycomb
- Curing at 40C in oven

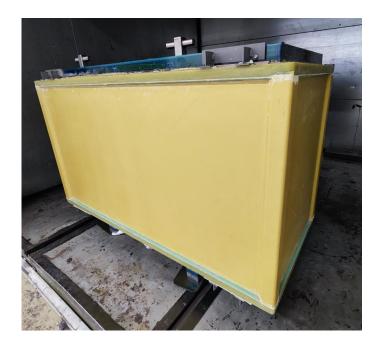




- Flipping the box top-bottom
- Resin casting on second flange
- Curing at 40C in autoclave
- Second Twaron peel lamination
- Curing at 40C in autoclave



Outer Twaron peel lamination

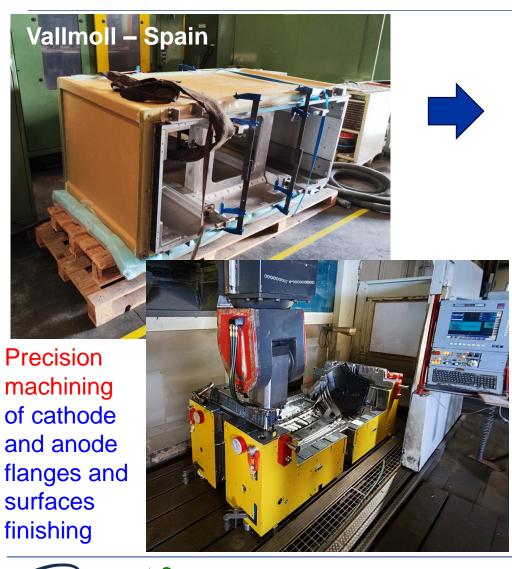


Post-curing at 40C in oven (lasting as long as possible)

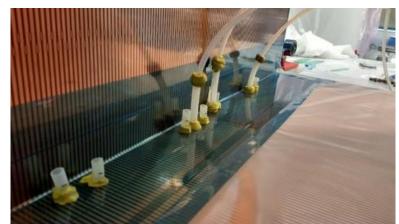
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Field Cage machining and final QC at Nexus



- Back to NEXUS company for
- Mould removal
- Very fine polishing of flanges
- Correction of defects (eg bubbles)









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The ND280 experiment: High Angle TPC highlights

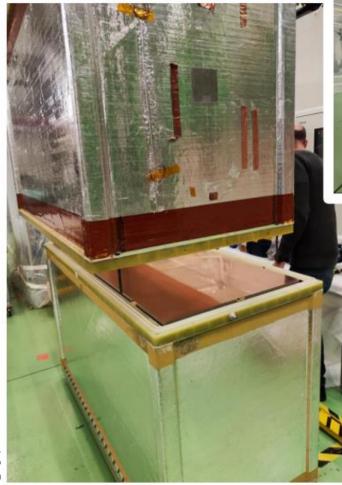
- Field Cage (FC)
 - Assembly and layout
 - Production
 - Characterization and Quality Assessment
 - Mechanical
 - Electrical
- Encapsulated Resistive Anode Micromegas (ERAMS)
 - Production of 50 sensors
 - Characterization
 - Detector response, signal and impact on reconstruction
- Impact on HATPC performance





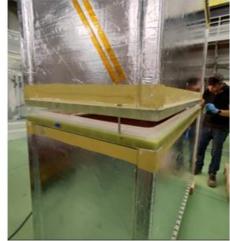
Field Cage assembling, characterization at CERN

Vertical assembly of two Field Cages into HATPC



INF

Cathode assembly





Cathode assembly



Connection of last strips to cathode and to high voltage feedtrough

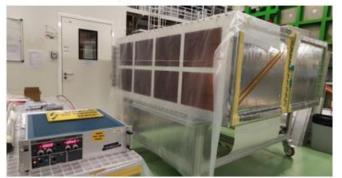






High Voltage feedtrough external connection

High voltage tests after assembly

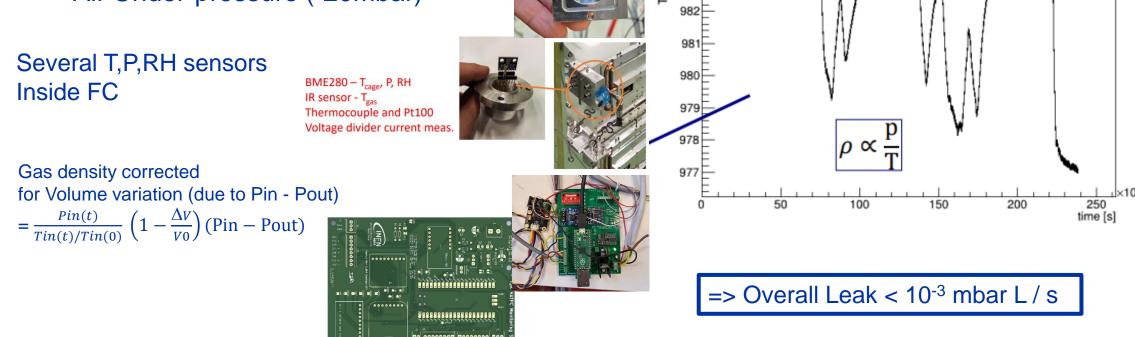




Field Cage assembling, characterization at CERN

- 1) He leak tested sniffer (air + 30mbar of He)
- 2) Tested against gas density changes
- He Over-pressure (+20mbar)
- Air Under-pressure (-20mbar)

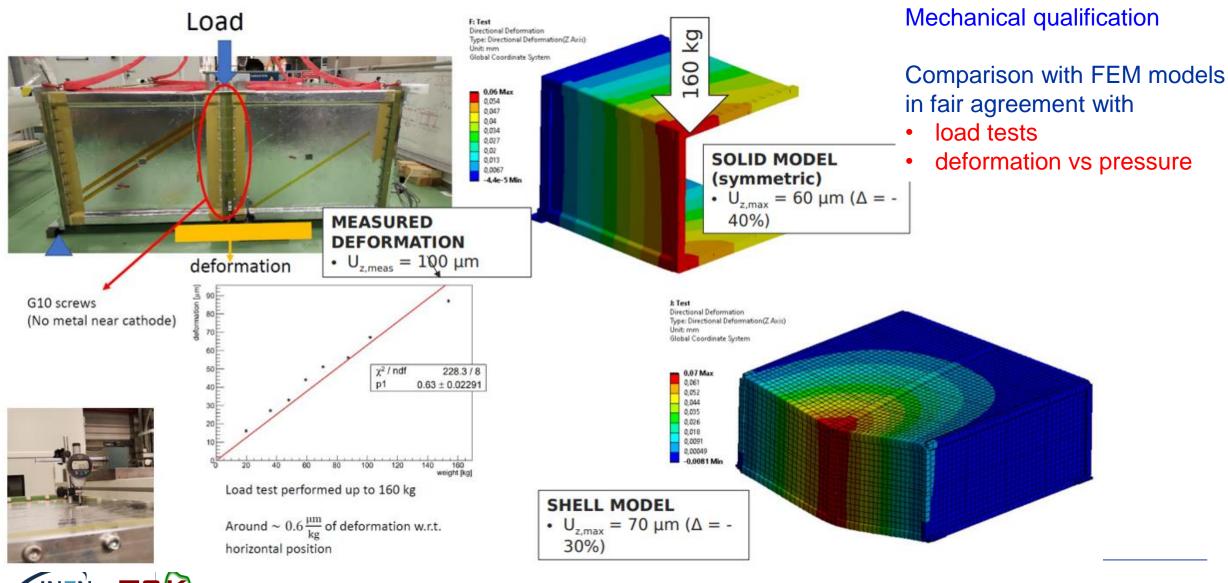
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[mbar]

Gas leakages qualification

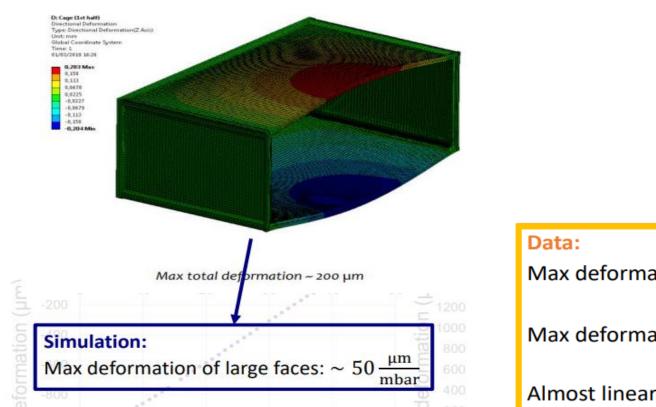
Field Cage assembling, characterization at CERN



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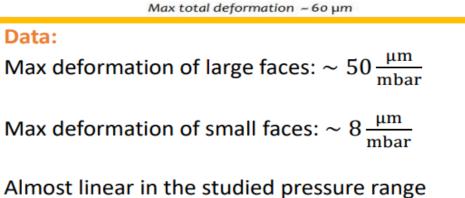
Field Cage assembling, characterization at CERN



Mechanical qualification

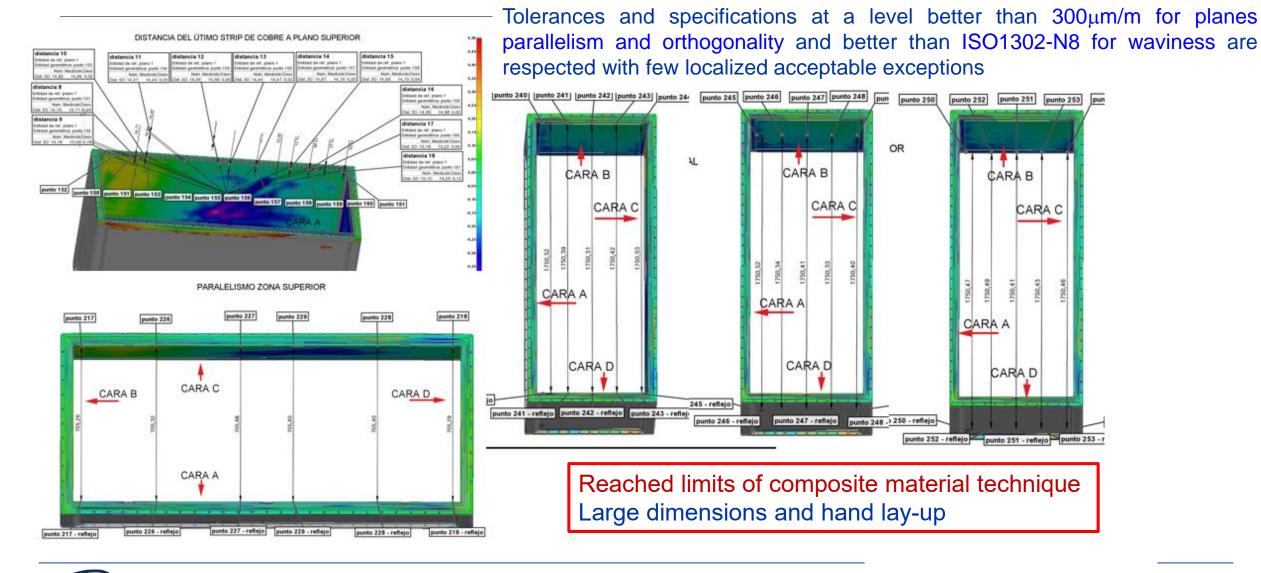
Comparison with FEM models in fair agreement with

- load tests
- deformation vs pressure

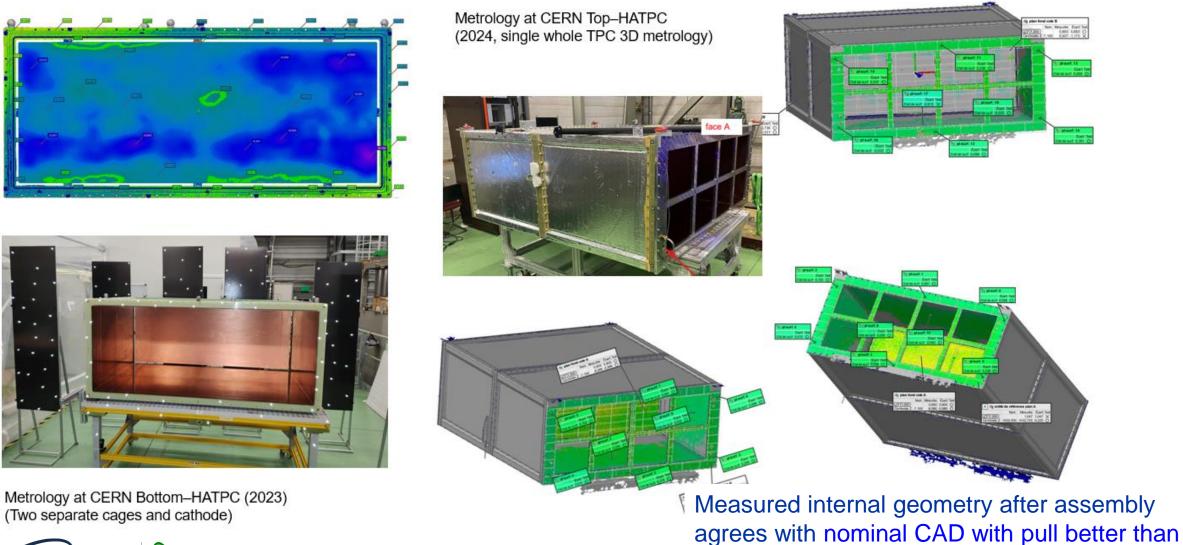


Field Cage assembling, metrology at Nexus

17.10.2023



Field Cage assembling, metrology at CERN



INFN T2 17.10.2023

MPGD 2024 | O

MPGD 2024 | Oct.14th - Oct.18th $300\mu m$ with few localized, acceptable exceptions

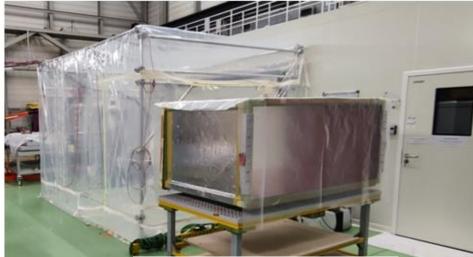
Field Cage assembling, ERAM installation

Assembly the 16 ERAMs in Clean room for each TPC

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Grey tent area in front of Clean Room large entrance for enhanced clean conditions

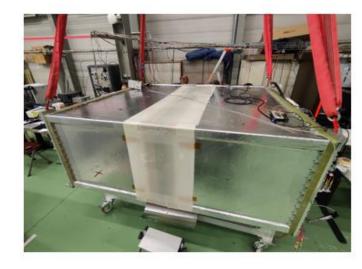


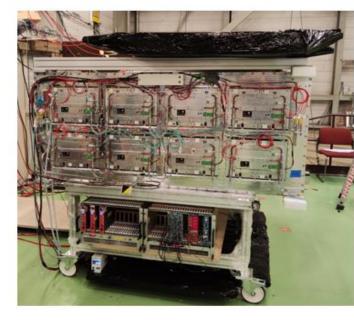
ERAMs: avoid dust

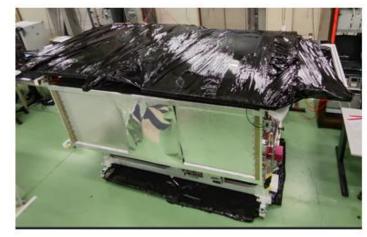


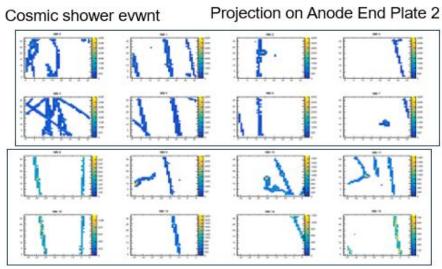
77

Field Cage assembling, commissioning with cosmics

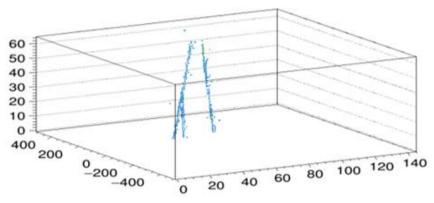








Projection on Anode End Plate 1



Cosmic tracks interaction evwnt

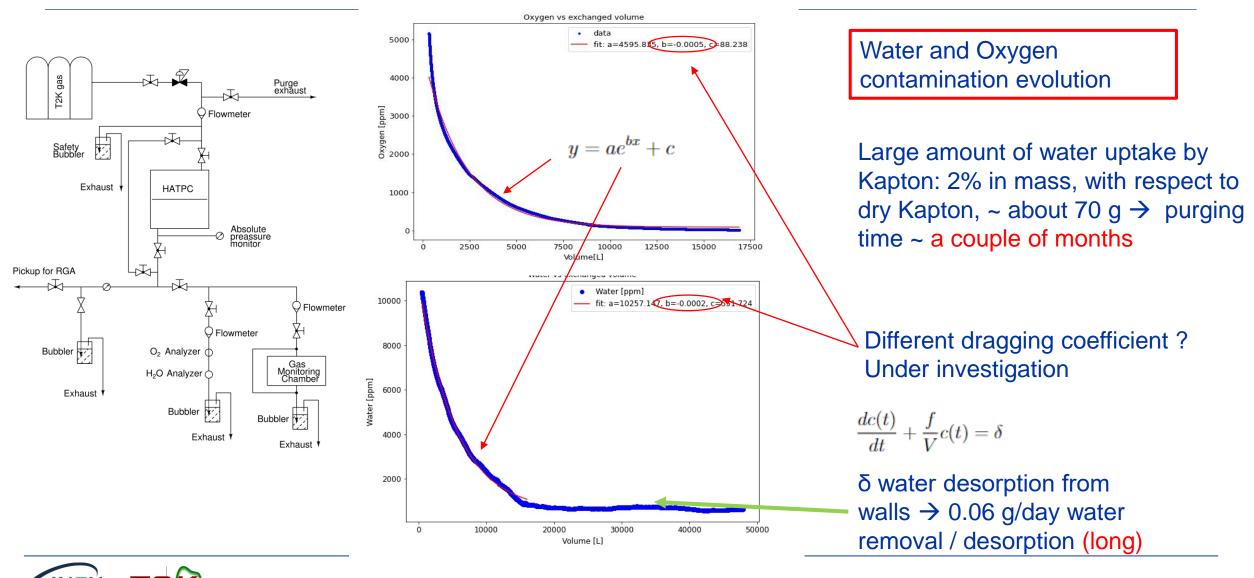


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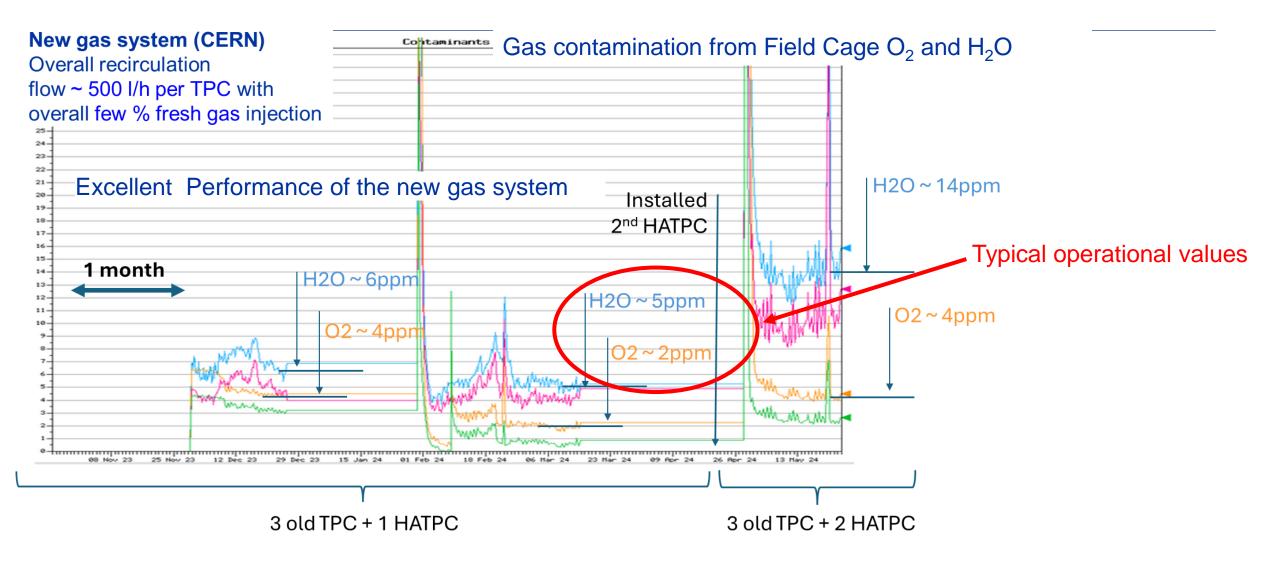
TZK

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Field Cage assembling, commissioning: gas contamination at CERN

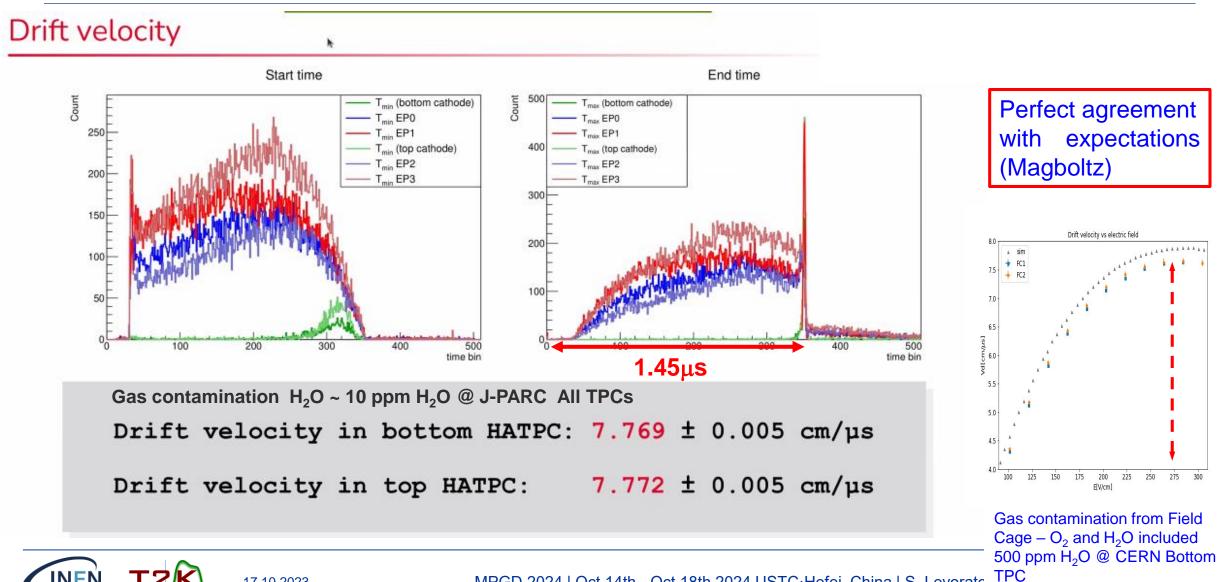


Field Cage assembling, commissioning: gas contamination at J-PARC



17.10.2023

Field Cage assembling, commissioning: drift velocity measurement



Thanks to CERN

We would like to express our gratitude for the continuous and extremely valuable support from CERN Burkard Schmidt, Roberto Guida, Frederic Merlet and colleagues \rightarrow Gas system EP-DT/ED-DT-FS Davide Tommasini, Roland Piccin, Sebastien Clement, Cedric Urscheler → Polymer lab/TE-MSC Rui de Olivera, Olivier Pizzirusso→ EP-DT-EF Eraldo Oliveri, Djunes Janssen \rightarrow EP-DT-DD Francesco Lanni, Lluis Secundino Miralles Verge Albert DE ROECK, Filippo Resnati → Neutrino Platform Ahmed Cherif, Jean Philipphe Rigaudt \rightarrow Metrology/TE-MSC-SMT Antie BEHRENS, Jean Christophe Gayde \rightarrow BE-GM-ESA Mauro Taborelli, Colette Charvet, Marcel Himmerlich \rightarrow TE-VSC-SCC Paolo Chiggiato \rightarrow TE-VSC

Patrick Muffat, Loredana ZENI Toberer, Laurence Planque, Stephanie Krattinger, Elsa Clerc→ SCE-SSC-LS





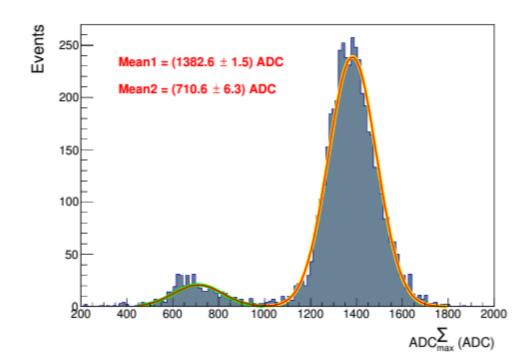
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Thanks to INFN support at CERN and the CEA ANTENNA colleagues

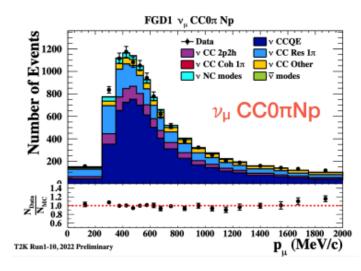
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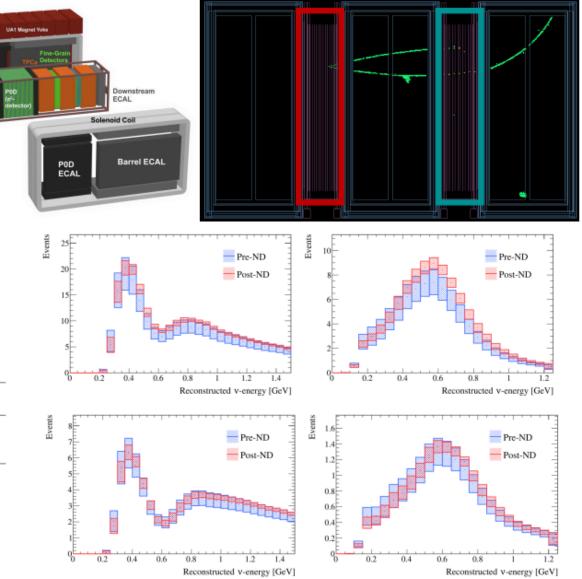


Near Detector impact on Oscillation Analysis

- ND280 magnetized detector
- Select interactions in FGD and measure muon kinematics in the TPCs
- Separate samples based on number of reconstructed pions (CC0π, CC1π, CCNπ), protons, photons, etc
- Factor of ~3 reduction on the uncertainty on the event rates at the Far Detector



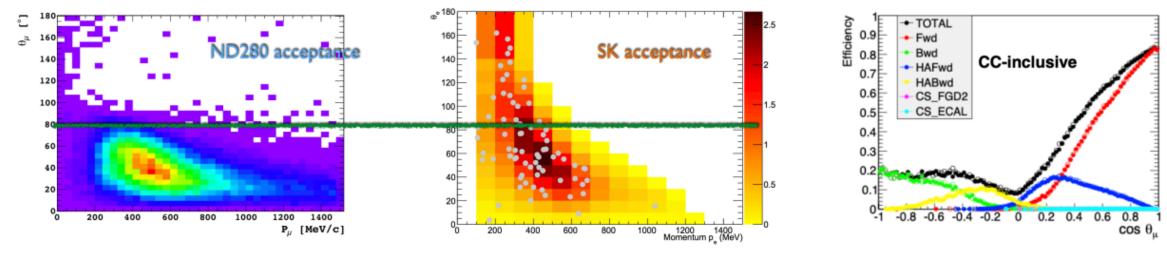
	Pre- ND FIT	Post- ND FIT
Sample	error	error
FHC $1R\mu$	11.1%	3.0%
RHC $1R\mu$	11.3%	4.0%
FHC 1Re	13.0%	4.7 %
RHC 1Re	12.1%	5.9%
FHC 1Re 1d.e.	18.7%	14.3%



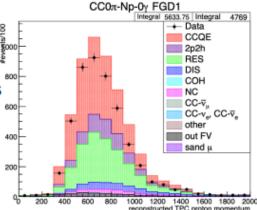
(e) v-mode 1Re

(d) v-mode 1Rµ

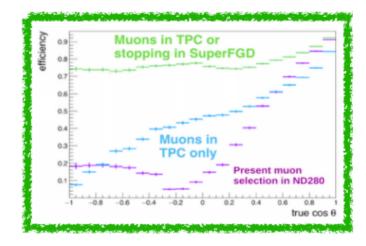
ND280 limitations

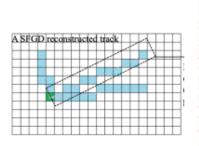


- Improve angular acceptance ν
- · Better reconstruction and usage of the hadronic part of the interactions!
 - Currently samples are selected according to their topology (0π, 1π, 1p, Nπ, ...) but the kinematics of the hadrons is not used in any way in the constraint on flux and x-sec systematics → plenty of additional information to be exploited
 - This is due to both, a low efficiency from ND280 to reconstruct hadrons and the difficulties in modeling the x-sec systematics for the hadronic part
 - With the upgrade we plan to improve the efficiency to reconstruct hadronic part

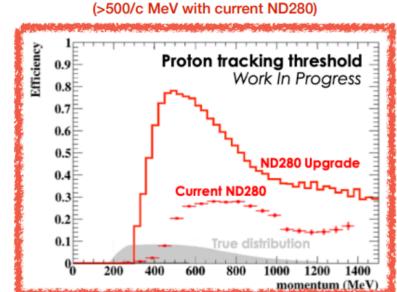


ND280 Upgrade improvements

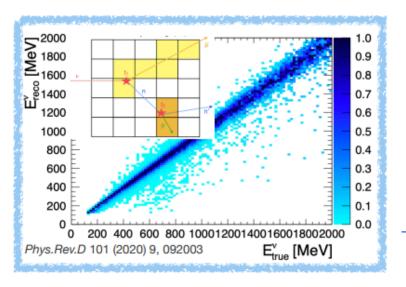




- High-Angle TPCs allow to reconstruct muons at any angle with respect to beam
- Super-FGD allow to fully reconstruct in 3D the tracks issued by v interactions →lower threshold and excellent resolution to reconstruct protons at any angle
 - Improved PID performances thanks to the high granularity and light yield
- Neutrons will also be reconstructed by using time of flight between vertex of v
 interaction and the neutron re-interaction in the detector



Protons → threshold down to 300 MeV/c



Mantle resistance

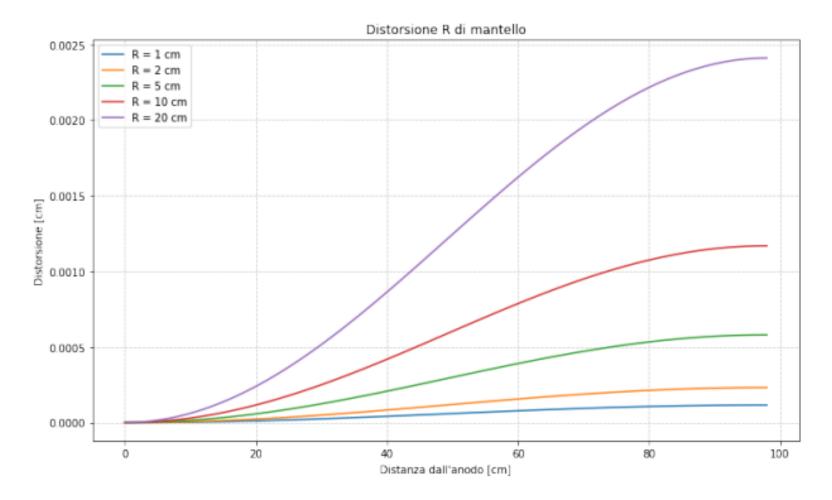


Figura 4.2: Spostamento lungo R del punto di arrivo di un elettrone causato da una resistenza R_{man} di un mantello isolante mille volte il valore della catena di resistori R. La distorsione é mostrata come funzione del punto di partenza z (Distanza dall'anodo).



ERAM Production - about 50 detectors

Crucial steps in production (needed tuning)

- 1) Selecting DLC foil resistivity
- Large variations from DLC provider
- Value stable after annealing
- 2) Gluing steps by Pressing
- DLC to PCB

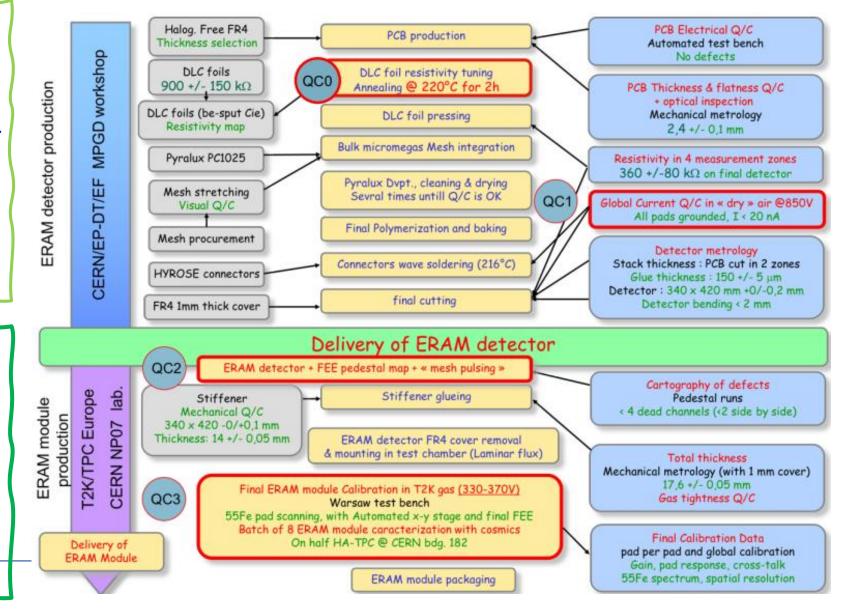
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- Stiffener to DLC-PCB

X-rays Test Bench at CERN was fundamental to

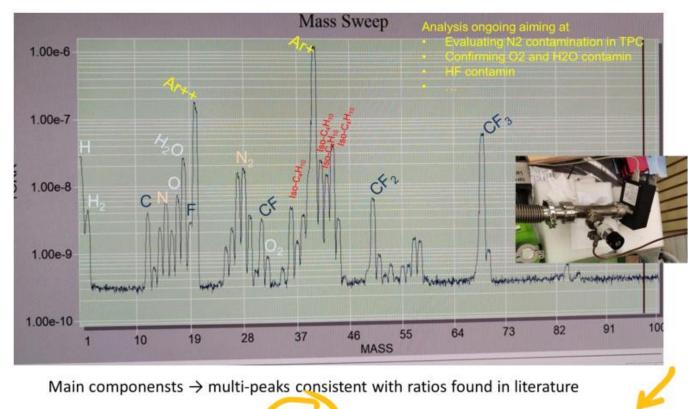
1) Qualify, characterize and calibrate all prototypes and series ERAMs

2) support the development of detailed ERAM response model



Field Cage assembling, characterization at CERN

Gas contamination from Field Cage – other contaminants



Analysis of gas composition during cosmics test in May

More accurate estimates ongoing

N2 analysis
 HCl acid

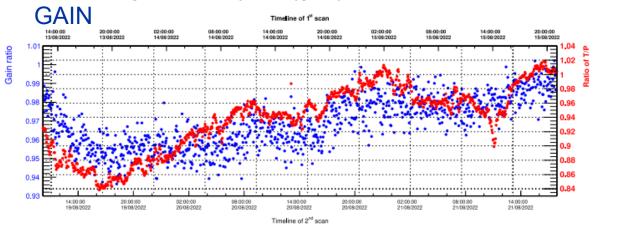
Evolution in time of components

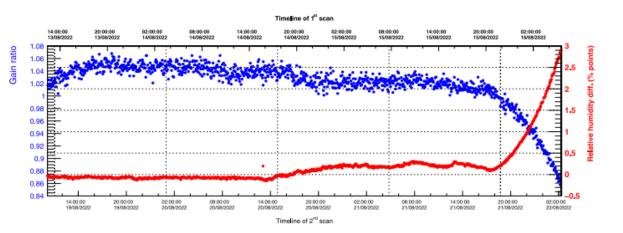
- H2O (+ HO) contamination $2\% \rightarrow c_{p}$ nsistent with other sensors (Vaisala)
- O2 peak below sensitivity → consistent with ppm level → need further checks

No HF acid a parently (below Ar++)

ERAM Series Production experience

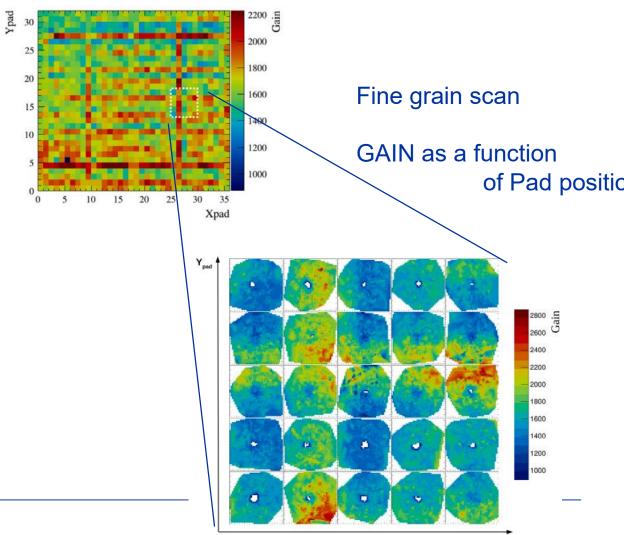
Effect of gas density on (gas)





GAIN

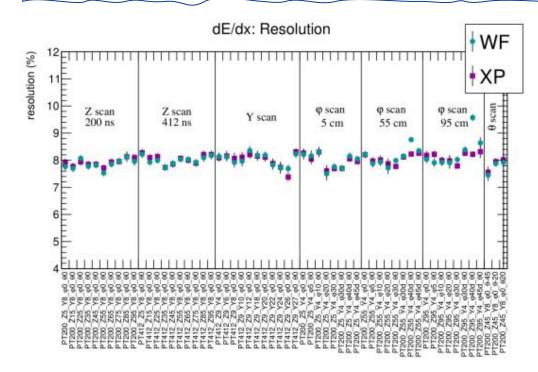
Effect of humidity on (gas)



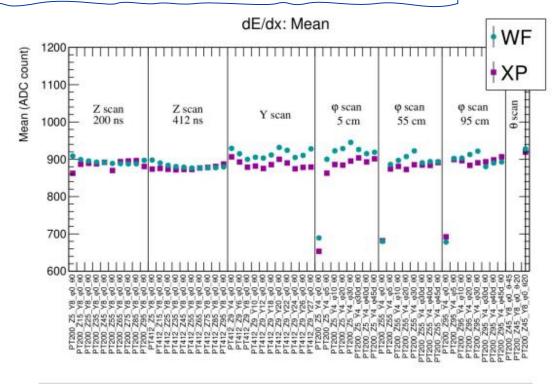


Reconstructing tracks dE/dx

dE/dx – comparison of SWF and XP methods on Test Beam data (4GeV electrons, DESY)

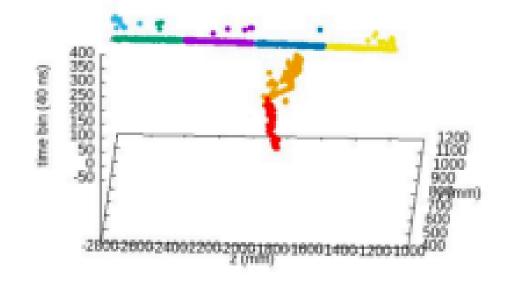


- Very good agreement overall
- Better resolution with XP with diagonal tracks

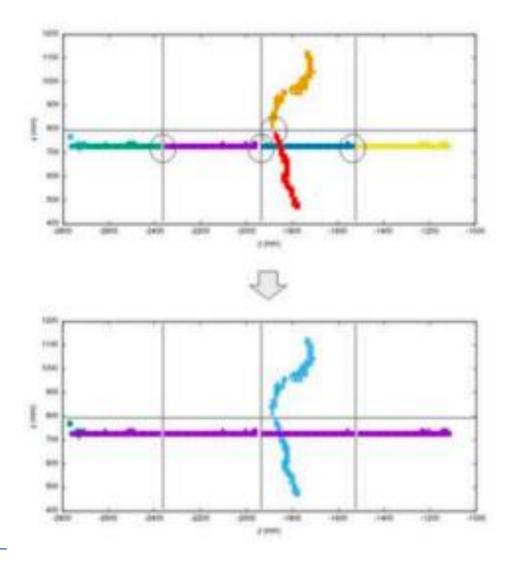


- Disagreement at small drift distance: reflects the track fitting quality
- Disagreement for Y scan: taken at small drift distance
- Disagreement for diagonal tracks: using only on correction function for WF_{sum} is not suitable

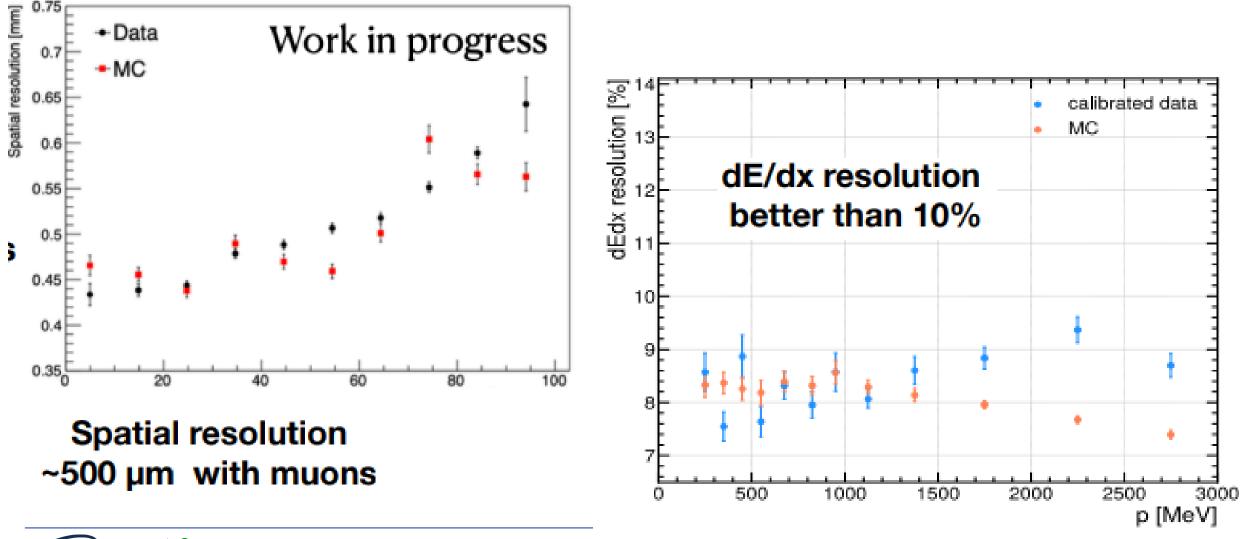
Reconstructing tracks – pattern recognition



- Time and charge definition for each hit
- Waveform multipeak search in order to differentiate vertices and crossing trajectories
- Merging between different ERAMs and End Plates

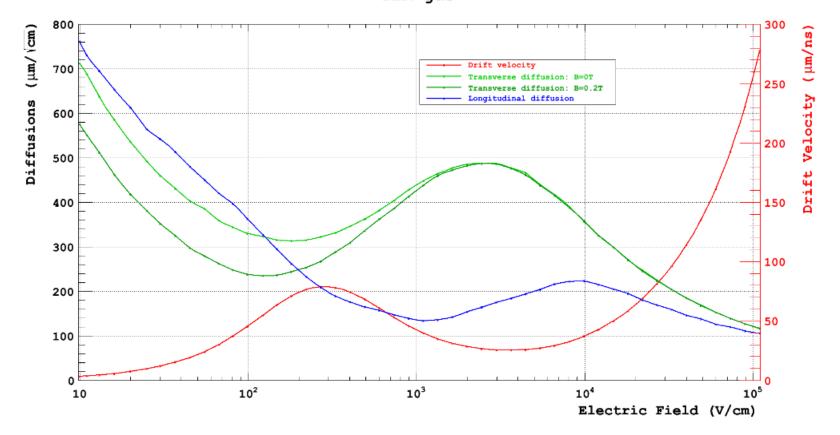


Reconstructing tracks – trajectory fitting



(INFN T2K)

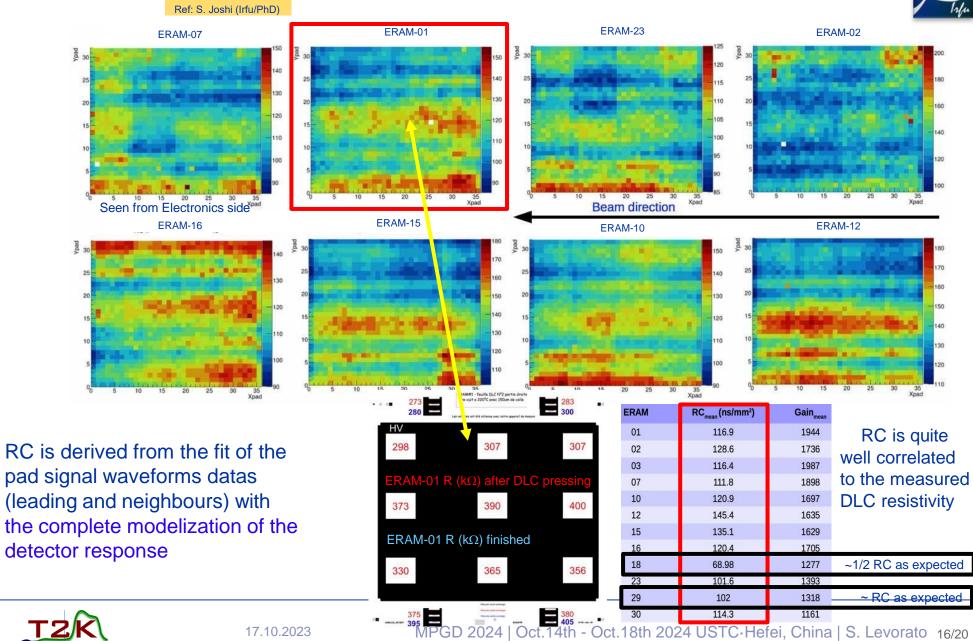
T2K gas properties



T2K gas







17.10.2023

INFŃ



Just in Case



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Figure 31: A map of gain non-uniformit shift of the mean amplitude reconstruct pad under study with respect to the me



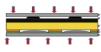
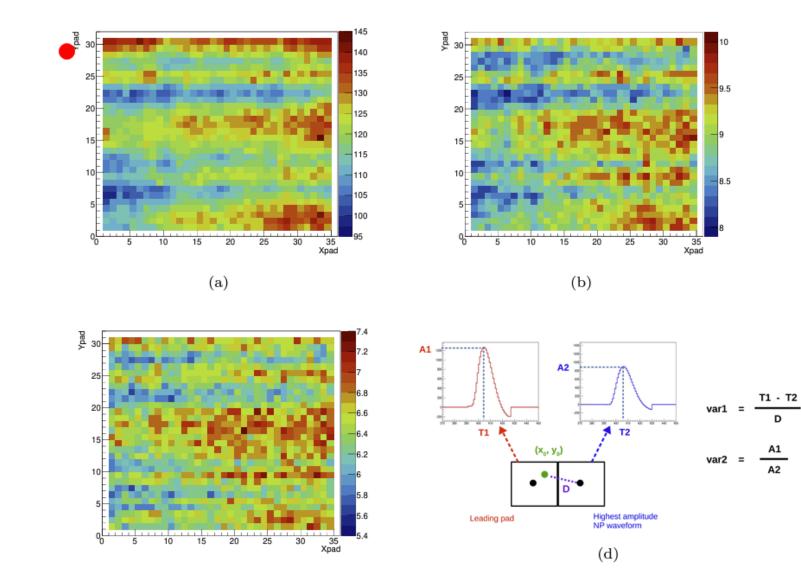


Figure 32: Schematic view of the DLC resulting in the non-uniformities observ The arrows represent the mechanical of when the soldermask is removed and rep



(c)

(

Figure 23: Comparing the features of an *RC* map (a) with the maps of two different basic-level variables (b) and (c) for ERAM-16. Variables var1 and var2 described in plot (d) are used to 700 months the maps/ (b) Data 24(c) respectively.8th 2024 USTC. Hefei, China | S. Levorato



99/20

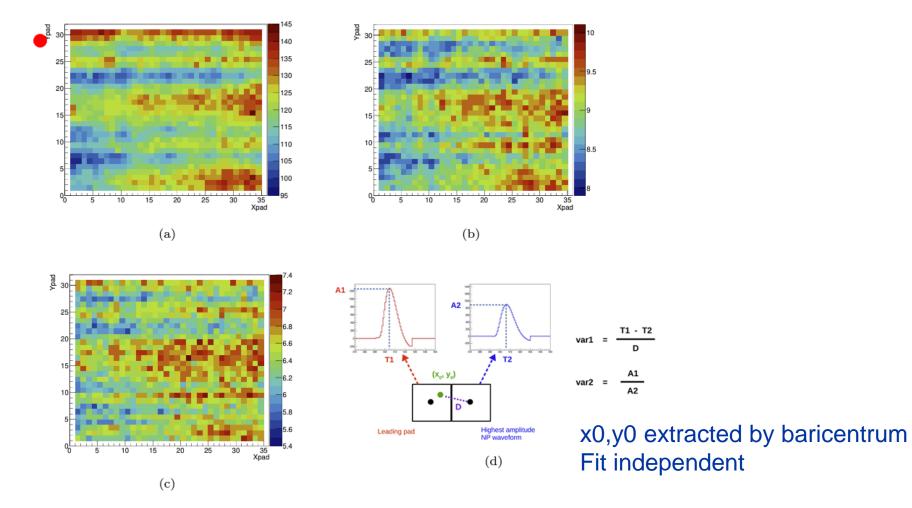


Figure 23: Comparing the features of an RC map (a) with the maps of two different basic-level variables (b) and (c) for ERAM-16. Variables var1 and var2 described in plot (d) are used to construct the maps (b) and (c) respectively.

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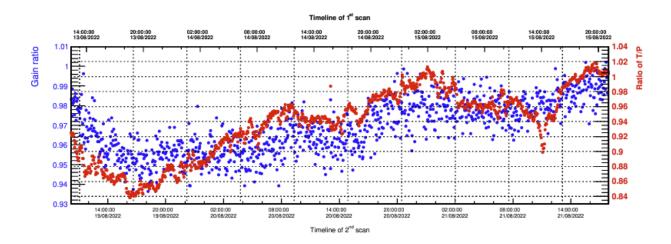


Figure 35: Effect of T/P on gain of an ERAM. The top and bottom x-axes represent the timelines of the two full detector scans.

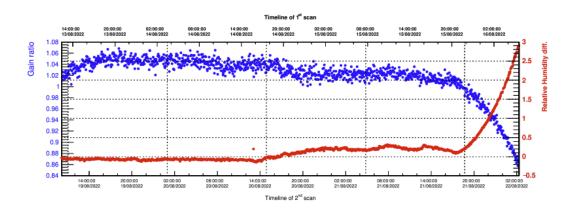


Figure 36: Effect of relative humidity on gain of an ERAM. The top and bottom x-axes represent the timelines of the two full detector scans.



Property Film Gauge	Typical V	Typical Value		Test Method
Dielectric Strength 25 μm (1 mil) 50 μm (2 mil) 75 μm (3 mil) 125 μm (5 mil)	V/μm (kV/mm) 303 240 201 154	(V/mil) (7700) (6100) (5,100) (3900)	60 Hz 1/4 in electrodes 500 V/sec rise	ASTM D-149
Dielectric Constant 25 μm (1 mil) 50 μm (2 mil) 75 μm (3 mil) 125 μm (5 mil)	3.4 3.4 3.5 3.5	3.4 3.5		ASTM D-150
Dissipation Factor 25 μm (1 mil) 50 μm (2 mil) 75 μm (3 mil) 125 μm (5 mil)	0.002 0.002	0.0018 0.0020 0.0020 0.0026		ASTM D-150
Volume Resistivity 25 μm (1 mil) 50 μm (2 mil) 75 μm (3 mil) 125 μm (5 mil)	Ω-cm 1.5 × 1 1.5 × 1 1.4 × 1 1.0 × 1	0 ¹⁷ 0 ¹⁷ 0 ¹⁷		ASTM D-257

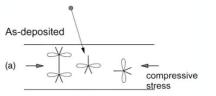
Table 7. Typical Electrical Properties of Kapton® Type HN and HPP-ST Films



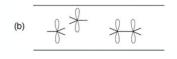
Although a-C:H and ta-C belong to the same material family, they are not produced by the same coating process. a-C:H is achieved by PECVD (Plasma Enhanced Chemical Vapor deposition) in a gaseous environment. Whereas ta-C is produced by PVD-arc (Physical Vapor deposition arc) from a solid carbon target. PVD-arc technology enables the production of a ta-C coating with a higher percentage of sp3 hybridization without hydrogen and providing a higher hardness.

• Thermal annealing of ta-C is well known

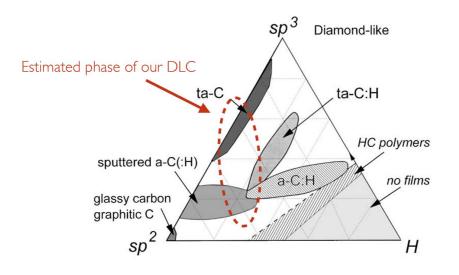
- a-C:H as well. But,
- "Thermal annealing of a-C:H also reduces the stress, as in ta-C. However, as the bonding in a-C:H is less stable during annealing, annealing is less useful in this case."
- Mechanism described
 - Thermal annealing converts a small fraction of sp³ (2%) to sp²
 - Distance between atoms is different between sp^2 and sp^3
 - New sp² structure has aligned electron orbitals
 - The conversion causes **exponential decrease** in resistivity
 - Compressive stress relieved by new sp² structure with electron orbitals aligned







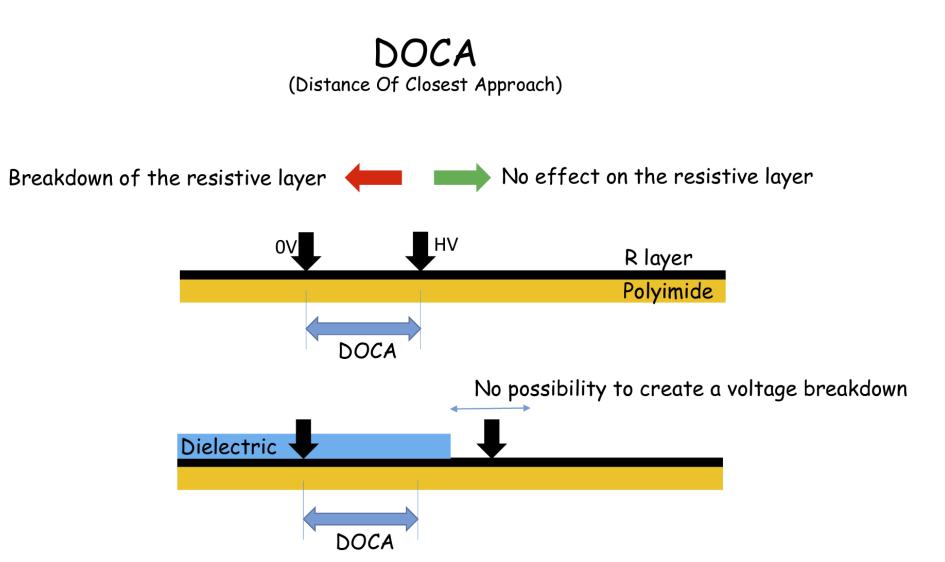
 σ orbital ∞ π orbital





S. Ban^A, W. Li^A, A. Ochi^B, W. Ootani^A, A. Oya^A, H. Suzuki^B, M. Takahashi^B (^AThe University of Tokyo, ^BKobe University)



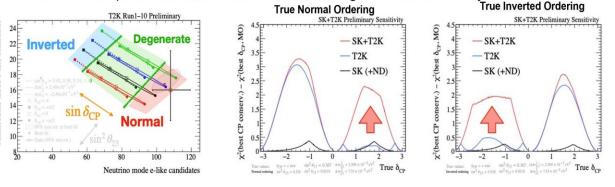


A breakdown of the resistive layer means creating a low Ohmic channel in the layer



T2K+SK joint analysis

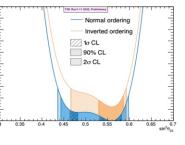
- T2K has good sensitivity to δ_{CP} but mild sensitivity to mass ordering
- SK has good constraint on mass ordering but not on δ_{CP}
- Adding SK atmospheric sample allows to break the degeneracies between the CP violation parameter δ_{CP} and the mass ordering \rightarrow boost sensitivity to CP



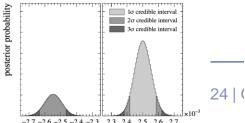
Mass ordering and θ_{23} octant

- Slight preference for normal ordering and upper octant but none of them is significative
 - Bayes factor NO/IO = 3.3
 - Bayes factor $(\theta_{23}>0.5)/(\theta_{23}<0.5) = 2.6$

	$\sin^2\theta_{23} < 0.5$	$\sin^2\theta_{23}>0.5$	Sum
NH $(\Delta m^2_{32}>0)$	0.23	0.54	0.77
IH $(\Delta m^2_{32} < 0)$	0.05	0.18	0.23
Sum	0.28	0.72	1.00



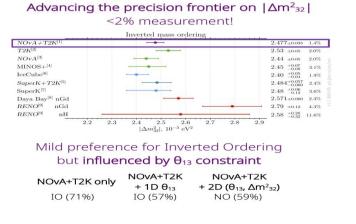
TZK



Both experiments individually prefer normal ordering and δCP ~- $\pi/2$, T2K prefers upper octant, SK prefer lower octant

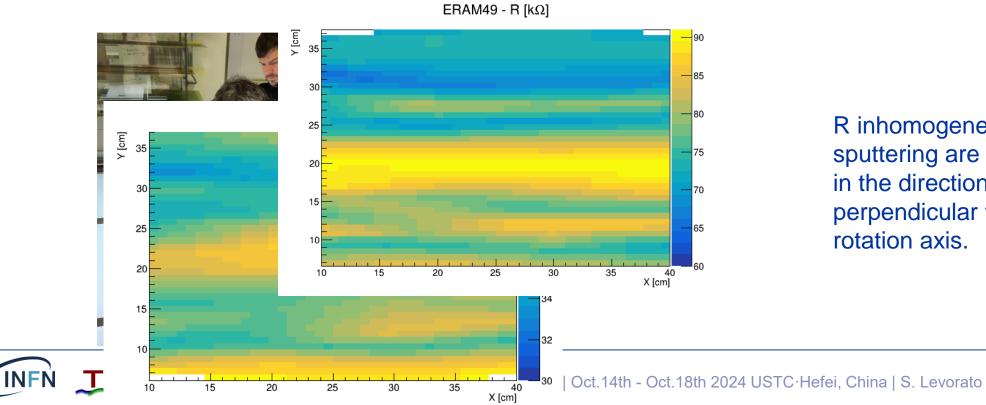
We performed Bayesian and Frequentist analyses \rightarrow frequentist analyses shown today

The CP-conserving value of the Jarlskog invariant is excluded with a significance between 1.9 and 2 σ

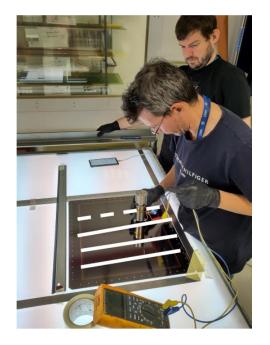


- NOvA & T2K's first joint results:
 - ⁻ Yield strong constraint on Δm_{32}^2
 - Weakly prefer IO or NO depending on which reactor constraint is applied
 - Strongly favor CP violation in Inverted Ordering
- Collaborations in active discussion about joint fit next steps

NOvA-T2K joint fit: takeaways



R inhomogeneities in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.



RC Map(ns/mm²) | ERAM30

15

INFN

20

25

30 35 Xpad 135

130

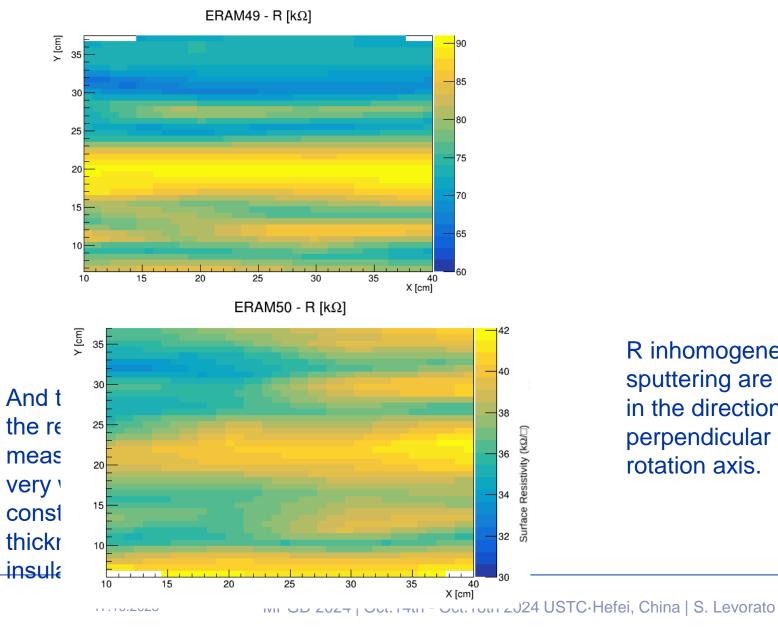
125

120

110

105

<u>چ</u> 30



R inhomogeneities in the sputtering are clearly visible in the direction perpendicular to the drum rotation axis.

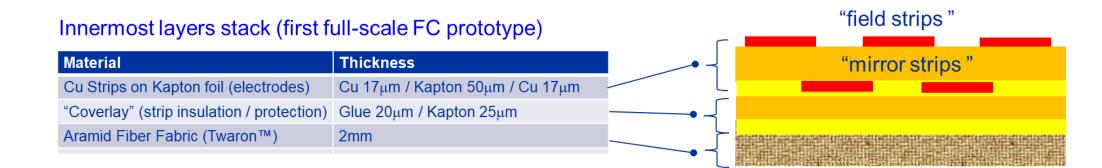
The ND280 experiment: High Angle TPC highlights

- Field Cage (FC)
 - Assembly and layout
 - Production
 - Characterization and Quality Assessment
 - Mechanical
 - Electrical

An outsider: Field Cage 0 ? Electrical Issues, what we understood... and learnt

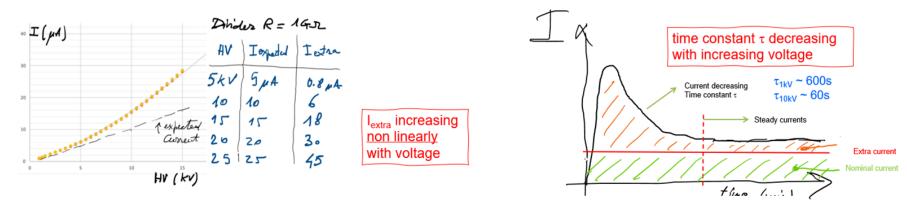


Insulation issue in full scale FC0 prototype



Current drawn by voltage divider starting in large excess wrt nominal at power on and slowly decreasing to lower value but still in excess

Current drawn by voltage divider starting in large excess wrt nominal at power on and slowly decreasing to lower value but still in excess



Observed extra-currents in excess w. r. t. expected from voltage divider



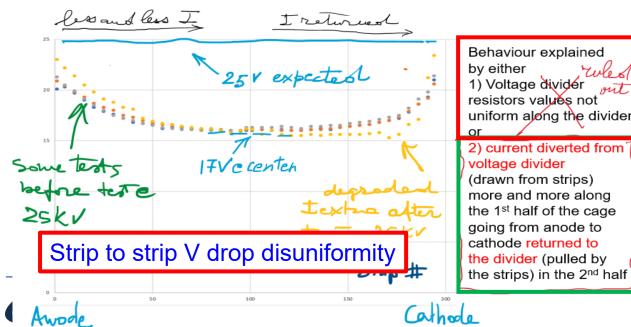
Insulation issue in full scale FC0 prototype

Innermost layers stack (first full-scale FC prototype)

Material	Thickness	
Cu Strips on Kapton foil (electrodes)	Cu 17 μ m / Kapton 50 μ m / Cu 17 μ m	-
"Coverlay" (strip insulation / protection)	Glue 20µm / Kapton 25µm	-
Aramid Fiber Fabric (Twaron™)	2mm	

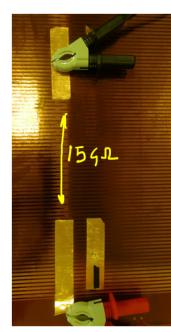
Strip-Strip Potential difference of the strips @ 5kV

Voltage difference between Field strips (every 5 strips) ie V_1 - V_2 , V_5 - V_6 , V_{10} - V_{11} , ... V_1 = anode, V_{196} = cathode



Measurement of Surface resistance of strip foil

(resistors removed)



Resistance between single strips is very high $O(T\Omega)$...but when joining some tens of strips to form a single large electrode then finite resistances are measured

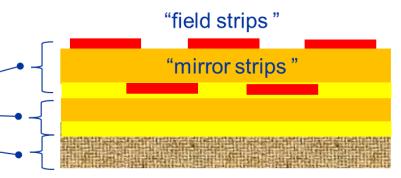
Example: measured R ~15 G Ω @ 1kV between two electrodes formed by 20Field+20Mirror strips each (surface of single electrode is huge ~ 0.5m²) ! No voltage divider there, ie all strips disconnected

Resistance is

- Independent of the distance between electrodes
- Linearly dependent of the number of the strips → not a surface resistance !

Measured R is rising with time (slow) up to saturation - when repeating measurement, go faster to saturation - when inverting polarity of electrodes, slow again → looks like due to dielectric polarization / relaxation → or capacitor charging trough high resistance

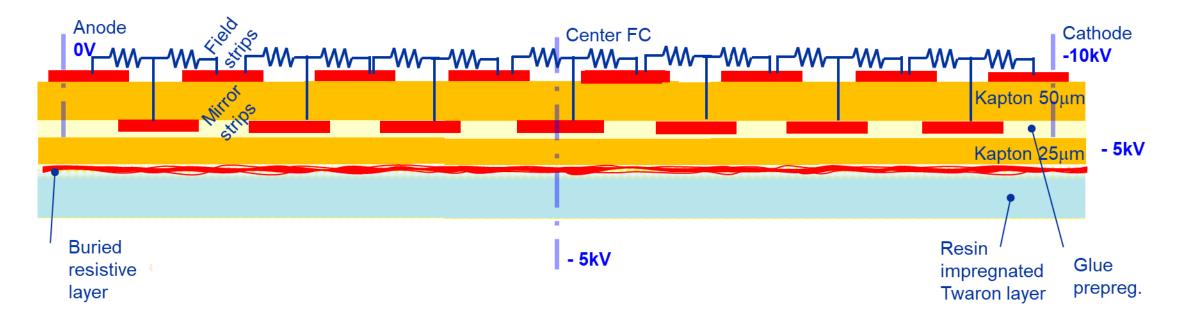
Find similar value of Resistance for same dimension _____ electrodes formed in the Field Cage and on a strips foil when aluminum foil is placed underneath the foil \rightarrow next 110



Buried resistive layer: a possible explanation

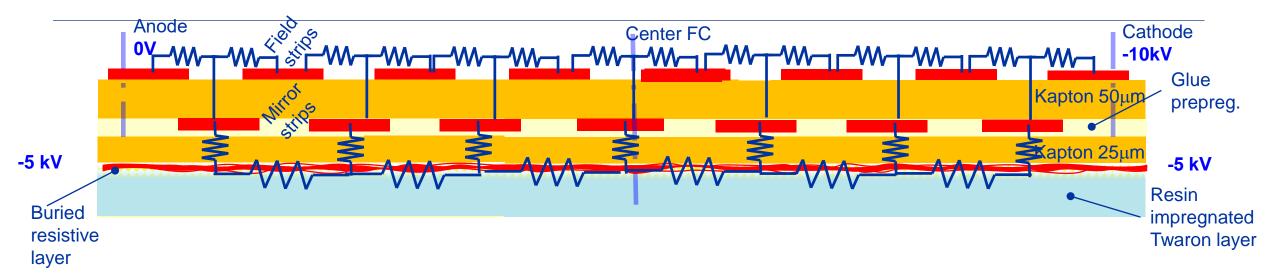
All observed features could be explained by the combination of two factors:

- 1) Presence of a resistive layer buried underneath the Kapton coverlay layer protecting the mirror Mirror strip
- 2) Low resistivity of the coverlay Kapton layer





Buried resistive layer: phenomenology



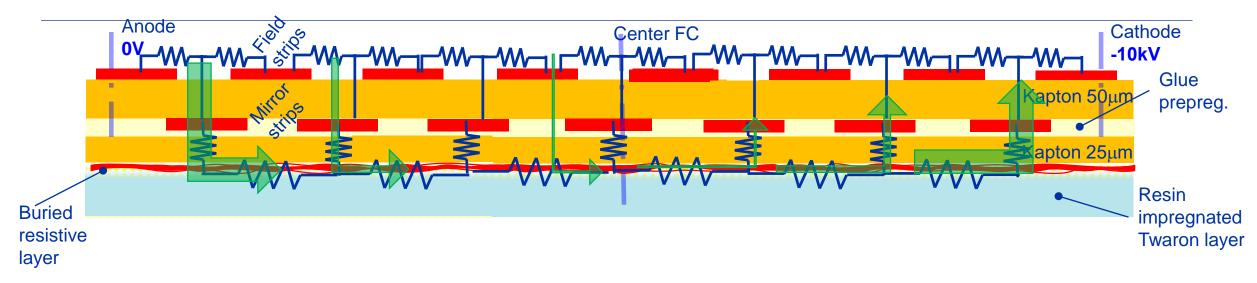
After applying HV after applying HV (eg -10kV) to the cathode, two phases:

 Transient state: in time scale depending on the contaminated layers resistivity (in our case very short O(10s) time scale) the buried resistive layer become ~ equipotential (setting at intermediate potential -5kV) by drawing charge from the strips

2) Steady state: Mirror strips on the Anode, first half convey current to the buried layer, while mirror strips on the Cathode side draw currents from the buried layer



Buried resistive layer: phenomenology



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2) Steady state: Mirror strips on the Anode, first half convey current to the buried layer, while mirror strips on the Cathode side draw currents from the buried layer



Buried resistive layer: verification

In fact we verified the following

- 1) Coverlay Kapton volume resistivity ~ $1G\Omega cm$ much lower than datasheet)
- 2) Twaron layer facing the coverlay featured surface resistivity $\sim 1G/\Box$

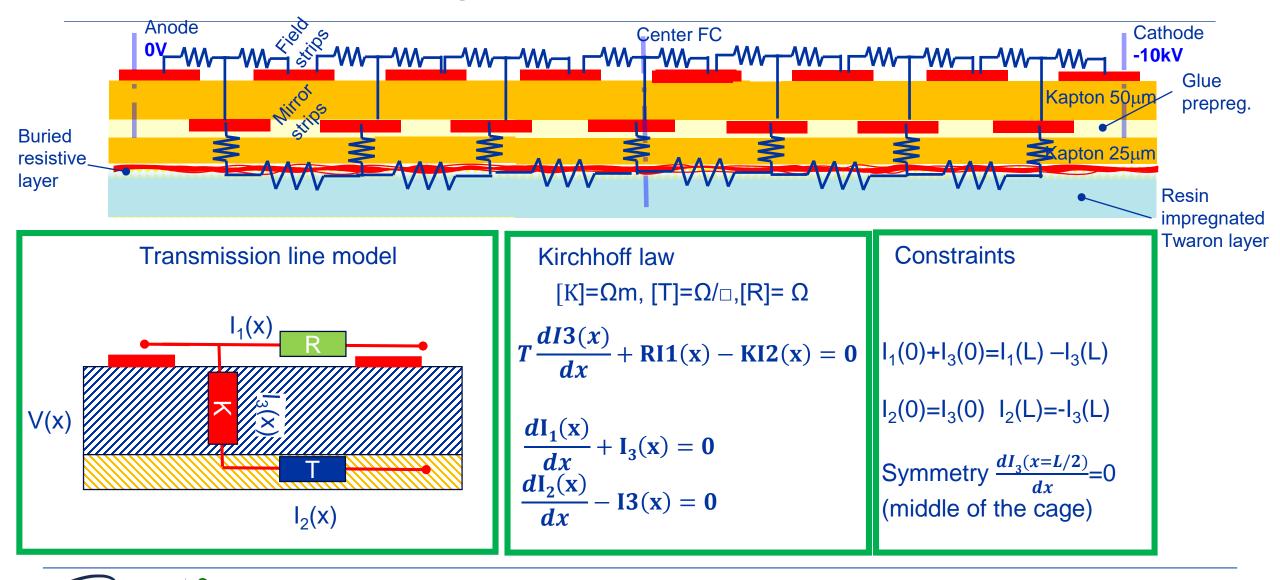


Both features could on turn be explained by the **accidental use of antistatic spray (resistive)** on the back of the strip foil (ie on the coverlay) after the strip foil was fixed on the Mould, in order to keep the huge foil surface (5m²) clean from dust and other possible contaminants. The spray contaminated both the Kapton coverlay (being very easily adsorbed) and the innermost layer of the Twaron (being mixed with the resin which impregnates the fiber fabric, during the Twaron lamination phase)

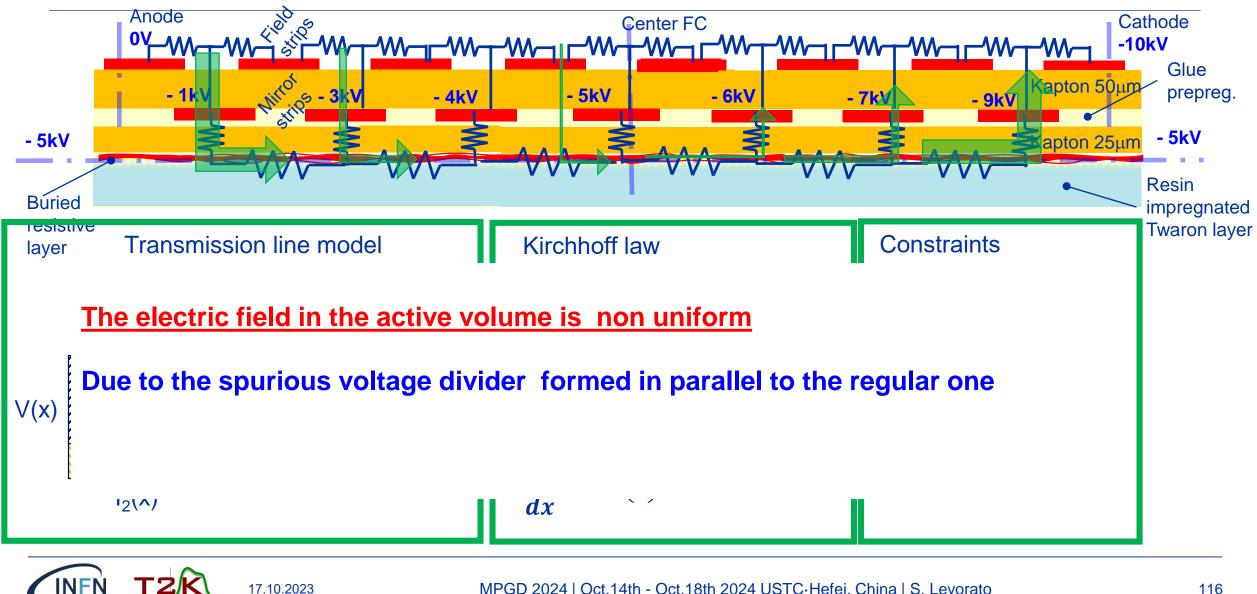
We could not exclude alternative sources of contamination affecting the resin and making it resistive (eg presence of water if epoxy not treated in vacuum after mixing)

Buried resistive layer: electrical model

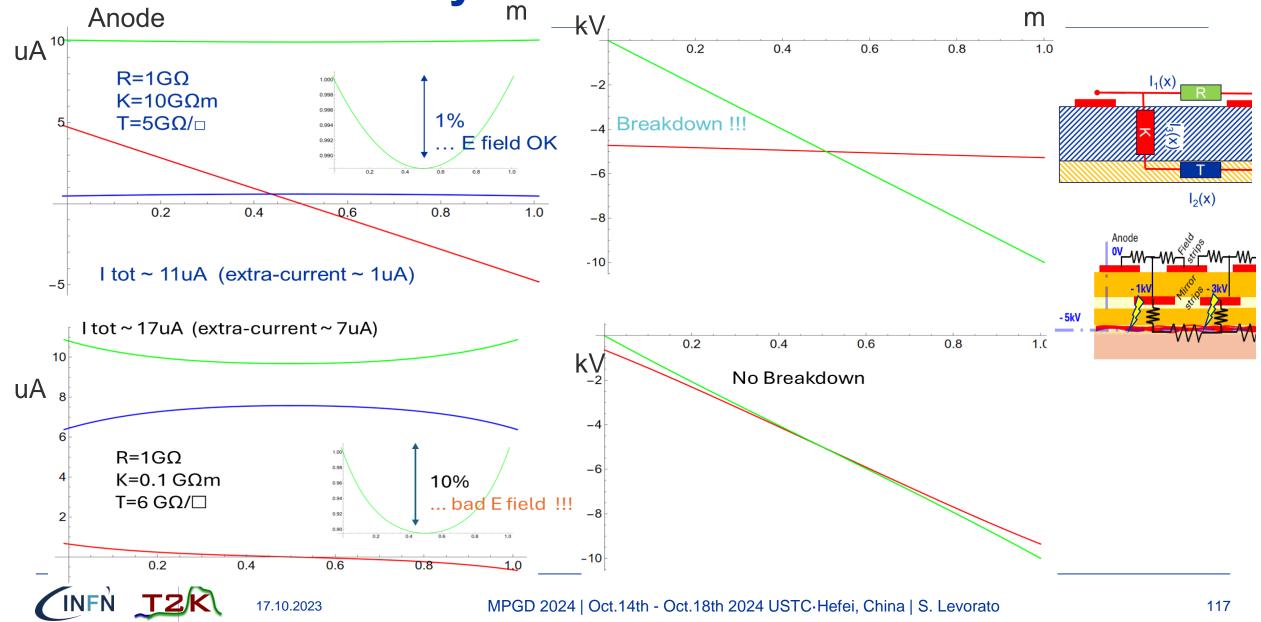
17.10.2023



Buried resistive layer: electrical model results

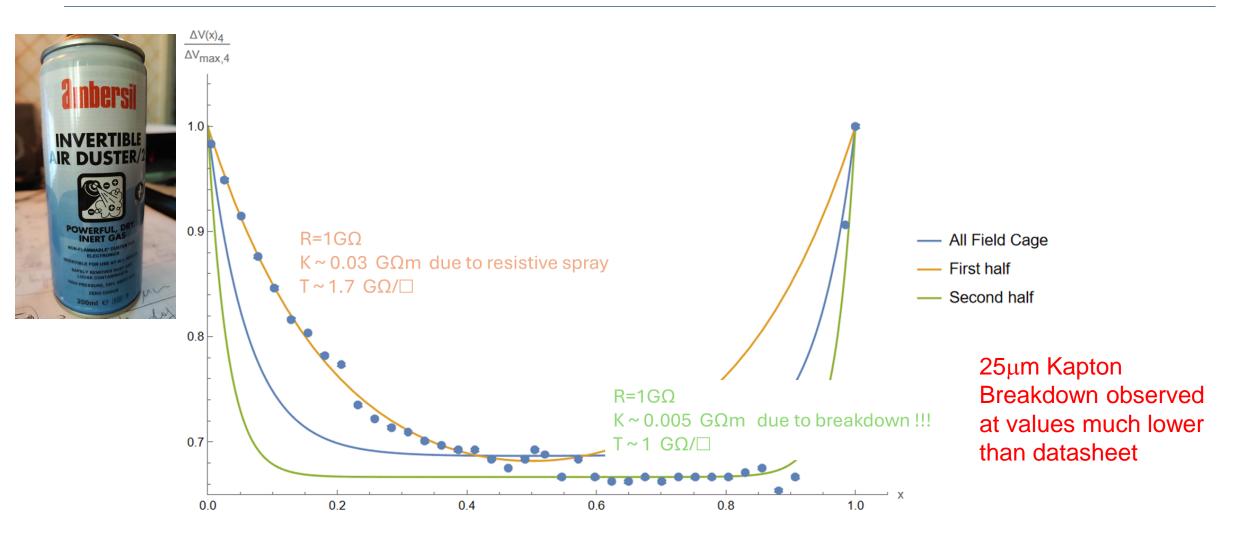


Buried resistive layer: electrical model results



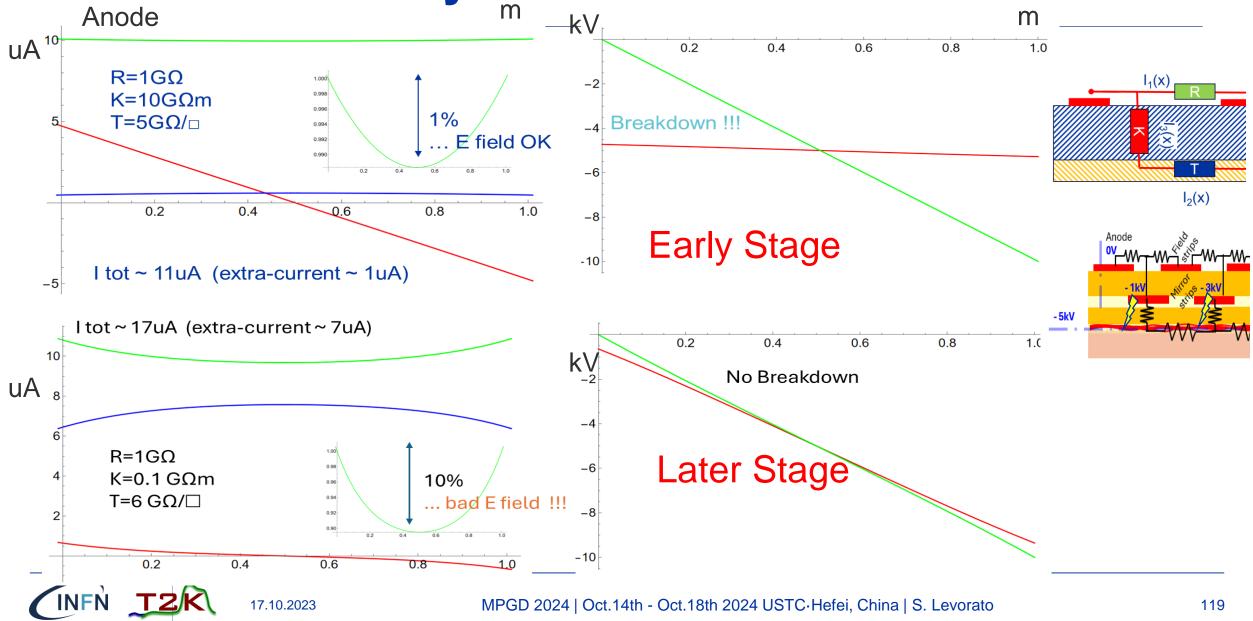
Buried resistive layer: fit to the data

17.10.2023

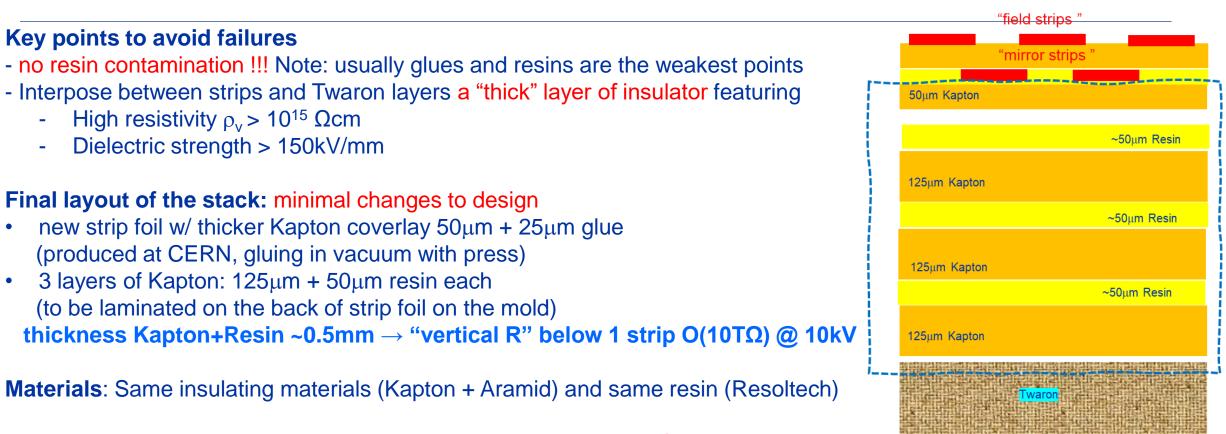




Buried resistive layer: electrical model results



Final layout, materials and procedures fixed for the series production



Production procedure and enhanced countermeasures and QC

- Minimize moisture trapped in wall layers: drying in oven Kapton & Twaron just before use
- QC epoxy contamination -> proper control of mixing and de-gassing process (new mixing / degassing tools and QC) and ... avoid antistatic spray...
- QC electrical resistivity measurements after each early step in the production

ND280: installations at J-PARC

TOF installation (July 2023)

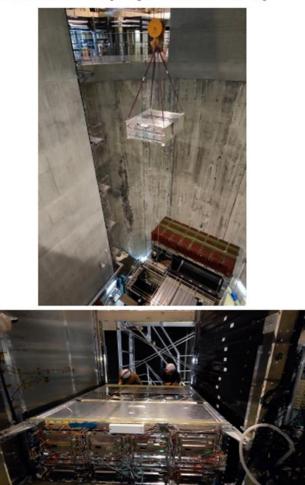




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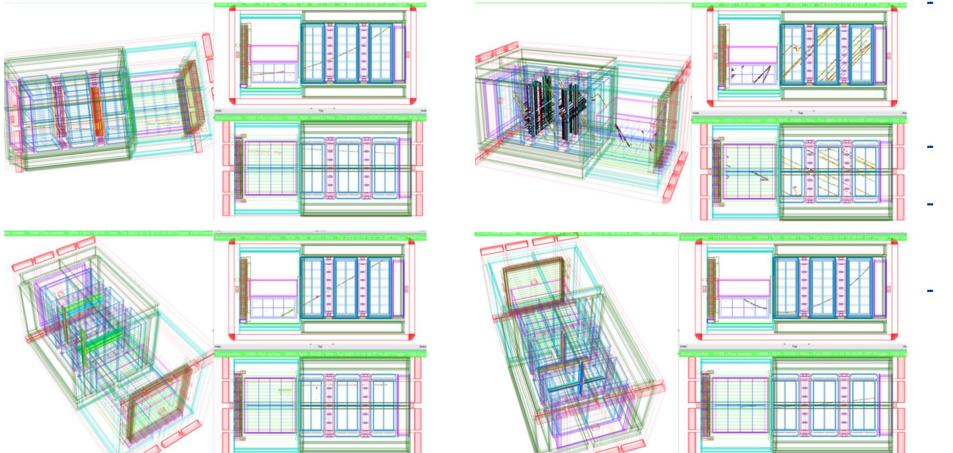
Bottom TPC installation (September 2023)



Super-FGD installation (October 2023)



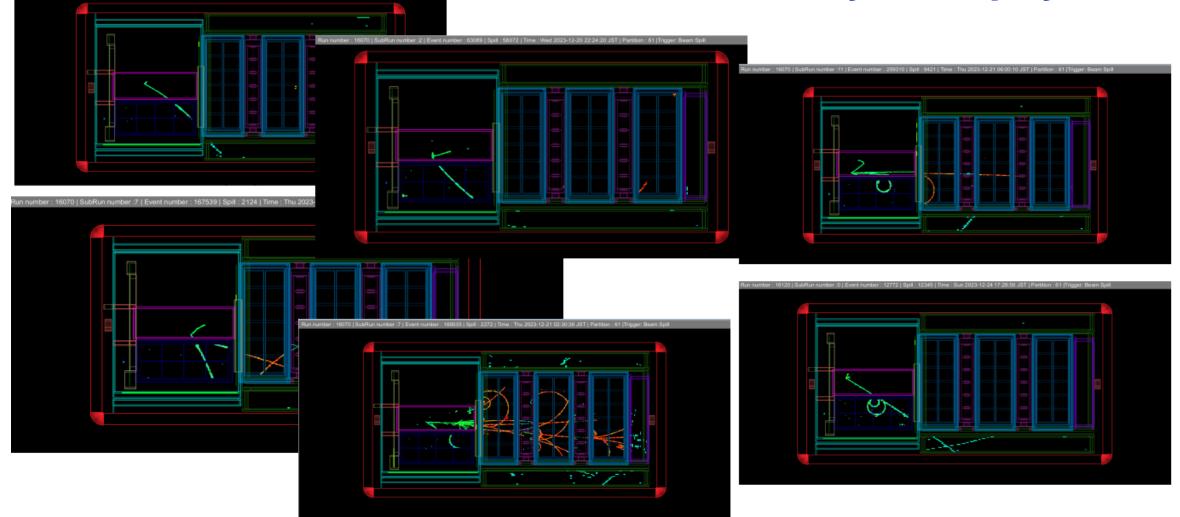
N280: commissioning at JPARC with cosmics



- Detector commissioning with and without magnetic field
- Alignment runs
- New software deployment
- New T2K gas system commissioning for both vertical and horizontal TPCs



N280: v technical runs in December 2023 and February 2024 physics run



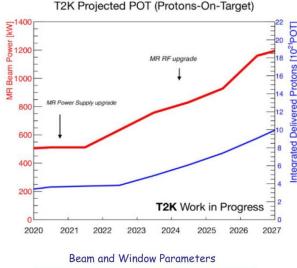
17.10.2023

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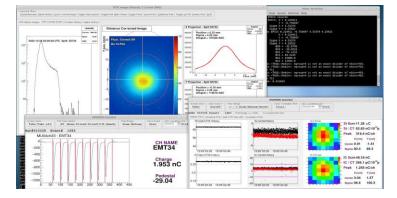
The T2K run schedule: beam upgrade

v beam @ J-PARC: dedicated upgrade of the MR facility to reach the 1.3 MW beam power



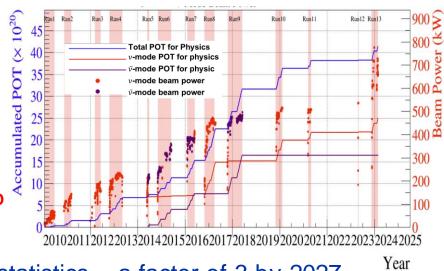
		750 kW	1.3MW
		Design	T2KII path
Beam Energy	[Gev]	30	30
Protons per spill	[-]	3.30E+14	3.20E+14
Energy deposited per kg per proton		2.52E-10	2.52E-10
Energy deposited per kg per pulse	[J/kg/pulse]	83300	80640
Cycle time	[s]	2.1	1.16
Spill length	[5]	4.13E-06	4.11E-06
Number of bunches	[-]	8	8
Bunch length	[ns]	58	40
Gap length	[ns]	523	541
Peak Heat Generation	[J/m^3/s]	8.15E+14	1.14E+15
Beam sigma	[mm]	4.24	4.24
Heat load per spill	[J/cc/pulse]	378.18	366.11
Heat load per sec	[W/cc]	180.09	315.61
Peak Temp per bunch	[C]	19.78	19.15
Thermal stress per bunch	[MPa]	61.27	59.32
Peak Temp per pulse	[C]	158.27	153.22
K(3		Science & Technology Facilities Cou Rutherford Appleton





Expect to select 20k ν_{μ} CC0pi interactions in the super-FGD for 0.2e21 POT (1 month)

December 2023 → Beam power increased from 500 to 760 kW stable mode 800 kW reached in 2024 for the first run with the fully upgraded ND280



Steady improvements to reach 1.3 MW by 2027 with an increase T2K statistics ~ a factor of 3 by 2027

17.10.2023